



DS125BR401 具有输入均衡 和输出去加重功能的低功耗 12.5Gbps 4 通道中继器

1 特性

- 综合型器件系列，具有经实践检验的系统互操作性
 - DS125BR111：单通道中继器
 - DS125BR401：四通道中继器
 - DS125BR800：八通道中继器
 - DS125MB203：双端口 2:1/1:2 多路复用器/开关
 - DS125DF410：支持时钟和数据恢复 (CDR) 的四通道单向重定时器
- 低功耗：每通道 65mW（典型值），可选择关闭不使用的通道
- 支持 PCIe“非限制性”输出和 10G-KR 链路协商
- 高级信号调节功能
 - 6.25GHz 时，支持高达 30dB 的接收均衡功能
 - 发送去加重功能高达 -12dB
 - 发送输出电压控制：700mV 至 1300mV
- 可通过引脚选择、EEPROM 或 SMBus 接口进行编程
- 单电源电压：2.5V 或 3.3V（可选）
- 40°C 至 85°C 的工作温度范围
- 5kV 人体放电模式 (HBM) 静电放电 (ESD) 额定电压
- 直通引脚分配：10mm × 5.5mm 54 引脚超薄型四方扁平无引线 (WQFN) 封装
- 支持的协议
 - sRIO, Infiniband, Interlaken, 通用公共无线接口 (CPRI), 开放基站架构协议 (OBSAI)
 - 其它私有接口高达 12.5Gbps

2 应用范围

- SAS/SATA（高达 6Gbps），光纤通道（高达 10GFC）
- PCIe 1 代/2 代/3 代、10G-KR、10GbE、XAUI、RXAUI

3 说明

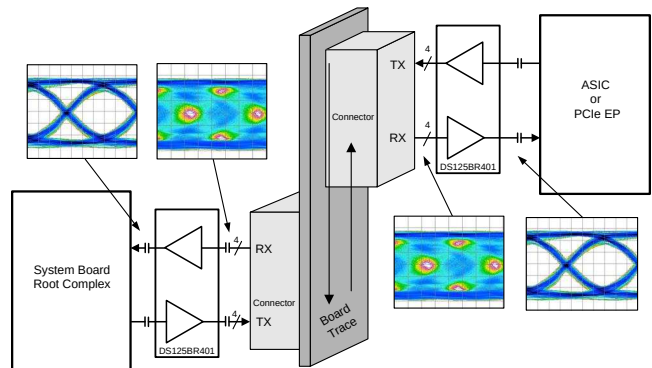
DS125BR401 器件是一款超低功耗高性能多协议中继器和转接驱动器，专用于支持速率高达 12.5Gbps 的四通道 PCIe 1 代/2 代/3 代、10G-KR 以及其他高速接口串行协议。接收器的连续时间线性均衡器 (CTLE) 可在 6.25GHz (12.5Gbps) 时为八个通道分别提供高达 30dB 的增强性能，能够打开一个因码间干扰 (ISI)（由 30 英寸以上的背板走线或 8 米以上铜缆等互连介质引起）而完全关闭的输入眼型状态，从而通过主机控制器确保实现无错误的端到端链接。发送器提供高达 -12dB 的去加重增强以及 700mV 至 1300mV 的输出电压幅度控制，以便在互连通道内的实体布局方面实现最大限度的灵活性。

器件信息⁽¹⁾

器件型号	封装	封装尺寸（标称值）
DS125BR401	WQFN (54)	10.00mm x 5.50mm

(1) 要了解所有可用封装，请见数据表末尾的可订购产品附录。

4 典型应用



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5 修订历史记录

Changes from Revision C (April 2013) to Revision D

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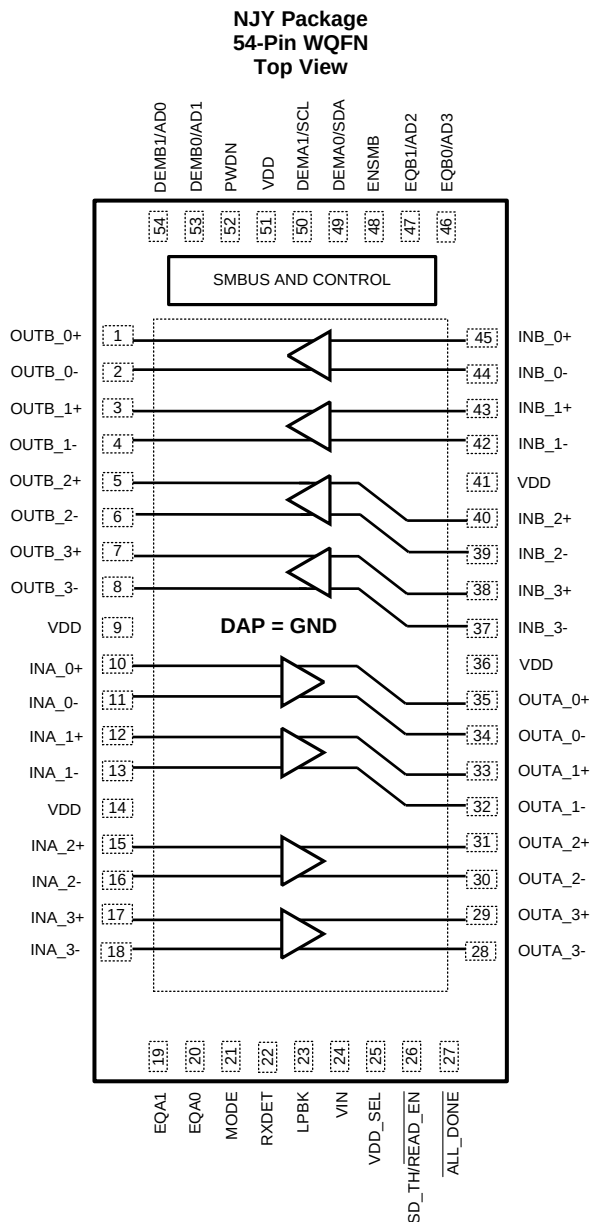
- 已添加 ESD 额定值表，特性描述部分，器件功能模式，应用和实施部分，电源相关建议部分，布局部分，器件和文档支持部分以及机械、封装和可订购信息部分 **1**

6 说明 (续)

在 10G-KR 和 PCIe 3 代模式下运行时, DS125BR401 允许主机控制器和端点优化完整链路并协商发射均衡器系数。这个链路协商协议的透明管理可以最短延迟扩展最大通道损耗。DS125BR401 采用节能系统设计, 每通道的功耗低至 65mW (典型值), 可选择关闭不使用的通道。需要一个 3.3V 或 2.5V 的单电源来为此器件供电。

可通过引脚、软件 (SMBus 或 I²C) 轻松应用该可编程设置, 或者通过外部 EEPROM 载入此设置。当运行在 EEPROM 模式下时, 配置信息在加电时自动载入, 这样就免除了对于外部微控制器或软件驱动程序的需要。

7 Pin Configuration and Functions



Pin Functions⁽¹⁾

PIN		I/O, TYPE	DESCRIPTION
NAME	NUMBER		
DIFFERENTIAL HIGH-SPEED I/Os			
INB_0+, INB_0-, INB_1+, INB_1-, INB_2+, INB_2-, INB_3+, INB_3-	45, 44, 43, 42 40, 39, 38, 37	I	Inverting and noninverting CML differential inputs to the equalizer. On-chip 50-Ω termination resistor connects INB_n+ to VDD and INB_n- to VDD when enabled. AC coupling required on high-speed I/O
OUTB_0+, OUTB_0-, OUTB_1+, OUTB_1-, OUTB_2+, OUTB_2-, OUTB_3+, OUTB_3-	1, 2, 3, 4 5, 6, 7, 8	O	Inverting and noninverting 50-Ω driver outputs with de-emphasis. Compatible with AC coupled CML inputs. AC coupling required on high-speed I/O
INA_0+, INA_0-, INA_1+, INA_1-, INA_2+, INA_2-, INA_3+, INA_3-	10, 11, 12, 13 15, 16, 17, 18	I	Inverting and noninverting CML differential inputs to the equalizer. On-chip 50-Ω termination resistor connects INA_n+ to VDD and INA_n- to VDD when enabled. AC coupling required on high-speed I/O
OUTA_0+, OUTA_0-, OUTA_1+, OUTA_1-, OUTA_2+, OUTA_2-, OUTA_3+, OUTA_3-	35, 34, 33, 32 31, 30, 29, 28	O	Inverting and noninverting 50-Ω driver outputs with de-emphasis. Compatible with AC coupled CML inputs. AC coupling required on high-speed I/O
CONTROL PINS — SHARED (LVCMOS)			
ENSMB	48	I, 4-LEVEL, LVCMOS	System Management Bus (SMBus) Enable pin Tie 1 kΩ to VDD = Register Access SMBus Slave mode FLOAT = Read External EEPROM (Master SMBUS Mode) Tie 1 kΩ to GND = Pin Mode
ENSMB = 1 (SMBUS MODE)			
SCL	50	I, 2-LEVEL, LVCMOS, O, OPEN Drain	ENSMB Master or Slave mode SMBUS clock input pin is enabled (slave mode). Clock output when loading EEPROM configuration (master mode).
SDA	49	I, 2-LEVEL, LVCMOS, O, OPEN Drain	ENSMB Master or Slave mode The SMBus bidirectional SDA pin is enabled. Data input or open-drain (pulldown only) output.
AD0-AD3	54, 53, 47, 46	I, 4-LEVEL, LVCMOS	ENSMB Master or Slave mode SMBus Slave Address Inputs. In SMBus mode, these pins are the user set SMBus slave address inputs. There are 16 addresses supported by these pins. Pins must be tied LOW or HIGH when used to define the device SMBus address.
READ_EN	26	I, 2-LEVEL, LVCMOS	When using an External EEPROM, a transition from high to low starts the load from the external EEPROM
ENSMB = 0 (PIN MODE)			
EQA0, EQA1 EQB0, EQB1	20, 19 46, 47	I, 4-LEVEL, LVCMOS	EQA[1:0] and EQB[1:0] control the level of equalization of the A/B sides as shown in . The pins are active only when ENSMB is deasserted (low). Each of the 4 A/B channels have the same level unless controlled by the SMBus control registers. When ENSMB goes high the SMBus registers provide independent control of each lane. The EQB[1:0] pins are converted to SMBUS AD2, AD3 inputs. See Table 2 .
DEMA0, DEMA1 DEMB0, DEMB1	49, 50 53, 54	I, 4-LEVEL, LVCMOS	DEMA[1:0] and DEMB[1:0] control the level of de-emphasis of the A/B sides as shown in . The pins are only active when ENSMB is deasserted (low). Each of the 4 A/B channels have the same level unless controlled by the SMBus control registers. When ENSMB goes high the SMBus registers provide independent control of each lane. The DEMA[1:0] pins are converted to SMBUS SCL/SDA and DEMB[1:0] pins are converted to AD0, AD1 inputs. See Table 3 .

- (1) LVCMOS inputs without the “Float” conditions must be driven to a logic low or high at all times or operation is not ensured.
 Input edge rate for LVCMOS/FLOAT inputs must be faster than 50 ns from 10–90%.
 For 3.3-V mode operation, VIN pin = 3.3 V and the VDD for the 4-level input is 3.3 V.
 For 2.5-V mode operation, VDD pin = 2.5 V and the VDD for the 4-level input is 2.5 V.

Pin Functions⁽¹⁾ (continued)

PIN		I/O, TYPE	DESCRIPTION
NAME	NUMBER		
MODE	21	I, 4-LEVEL, LVCMOS	MODE control pin selects operating modes. Tie 1 kΩ to GND = PCIe Gen-1 or PCIe Gen-2 and SAS/SATA (up to 6 Gbps) FLOAT = AUTO Rate Select (for PCIe) Tie 20 kΩ to GND = PCIe Gen-3 without De-emphasis Tie 1 kΩ to VDD = 10G-KR See Table 6
SD_TH	26	I, 4-LEVEL, LVCMOS	Controls the internal Signal Detect Threshold. For datarates above 8 Gbps the Signal Detect function should be disabled to avoid potential for intermittent data loss. See Table 5 .
CONTROL PINS — BOTH PIN AND SMBUS MODES (LVCMOS)			
RXDET	22	I, 4-LEVEL, LVCMOS	The RXDET pin controls the receiver detect function. Depending on the input level, a 50 Ω or >50 kΩ termination to the power rail is enabled. See Table 4 .
LPBK	23	I, 4-LEVEL, LVCMOS	Controls the loopback function Tie 1 kΩ to GND = Root Complex Loopback (INA_n to OUTB_n) Float = Normal Operation Tie 1 kΩ to VDD = End-point Loopback (INB_n to OUTA_n)
VDD_SEL	25	I, LVCMOS	Controls the internal regulator Float = 2.5-V mode Tie GND = 3.3-V mode
PWDN	52	I, LVCMOS	Tie High = Low power - power down Tie GND = Normal Operation See Table 4 .
ALL_DONE	27	O, LVCMOS	Valid Register Load Status Output HIGH = External EEPROM load failed LOW = External EEPROM load passed
POWER			
VIN	24	Power	In 3.3-V mode, feed 3.3 V to VIN In 2.5-V mode, leave floating.
VDD	9, 14, 36, 41, 51	Power	Power supply pins CML/analog 2.5-V mode, connect to 2.5 V 3.3-V mode, connect 0.1-μF capacitor to each VDD pin
GND	DAP	Power	Ground pad (DAP - die attach pad). See Power Supply Recommendations for proper power supply decoupling.

8 Specifications

8.1 Absolute Maximum Ratings⁽¹⁾

	MIN	MAX	UNIT
Supply Voltage (VDD - 2.5 V)	–0.5	2.75	V
Supply Voltage (VIN - 3.3 V)	–0.5	4	V
LVCMOS Input/Output Voltage	–0.5	4	V
CML Input Voltage	–0.5	(V _{DD} + 0.5)	V
CML Input Current	–30	30	mA
Junction Temperature		125	°C
Lead Temperature Range Soldering (4 sec.) ⁽²⁾		260	°C
Storage Temperature, T _{stg}	–40	125	°C

- (1) Stresses beyond those listed under *Absolute Maximum Ratings* may cause permanent damage to the device. These are stress ratings only, which do not imply functional operation of the device at these or any other conditions beyond those indicated under *Recommended Operating Conditions*. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

- (2) For soldering specifications: See application note [SNOA549](#).

8.2 ESD Ratings

			VALUE	UNIT
$V_{(ESD)}$	Electrostatic discharge	Human body model (HBM), per ANSI/ESDA/JEDEC JS-001, all pins ⁽¹⁾	±5000	V
		Charged device model (CDM), per JEDEC specification JESD22-C101, all pins ⁽²⁾	±1000	
		Machine model (MM), JESD22-A115-A	±150	

(1) JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.

(2) JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.

8.3 Recommended Operating Conditions

The *Recommended Operating Conditions* indicate conditions at which the device is functional and the device should not be operated beyond such conditions. Absolute maximum numbers are specified for a junction temperature range of -40°C to 125°C . Models are validated to maximum operating voltages only.

	MIN	NOM	MAX	UNIT
Supply Voltage (2.5-V mode)	2.375	2.5	2.625	V
Supply Voltage (3.3-V mode)	3.0	3.3	3.6	V
Ambient Temperature	-40	25	85	$^{\circ}\text{C}$
SMBus (SDA, SCL)			3.6	V
Supply Noise up to 50 MHz ⁽¹⁾			100	mVp-p

(1) Allowed supply noise (mVp-p sine wave) under typical conditions.

8.4 Thermal Information

THERMAL METRIC ⁽¹⁾		DS125BR401	UNIT
		NJY [WQFN]	
		54 PINS	
$R_{\theta JA}$	Junction-to-ambient thermal resistance	26.6	$^{\circ}\text{C/W}$
$R_{\theta JC(top)}$	Junction-to-case (top) thermal resistance	10.8	$^{\circ}\text{C/W}$
$R_{\theta JB}$	Junction-to-board thermal resistance	4.4	$^{\circ}\text{C/W}$
Ψ_{JT}	Junction-to-top characterization parameter	0.2	$^{\circ}\text{C/W}$
Ψ_{JB}	Junction-to-board characterization parameter	4.3	$^{\circ}\text{C/W}$
$R_{\theta JC(bot)}$	Junction-to-case (bottom) thermal resistance	1.5	$^{\circ}\text{C/W}$

(1) For more information about traditional and new thermal metrics, see the *Semiconductor and IC Package Thermal Metrics* application report, [SPRA953](#).

8.5 Electrical Characteristics

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
POWER						
PD	Power Dissipation	VDD = 2.5-V supply, EQ Enabled, VOD = 1 Vp-p, RXDET = 1, PWDN = 0		500	700	mW
		VIN = 3.3-V supply, EQ Enabled, VOD = 1 Vp-p, RXDET = 1, PWDN = 0		660	900	
LVCMOS / LVTTTL DC SPECIFICATIONS						
V _{IH25}	High Level Input Voltage	2.5-V Mode	2.0		VDD	V
V _{IH33}	High Level Input Voltage	3.3-V Mode	2.0		VIN	V
V _{IL}	Low Level Input Voltage		0		0.8	V
V _{OH}	High Level Output Voltage (ALL_DONE pin)	I _{oh} = −4 mA	2.0			V
V _{OL}	Low Level Output Voltage (ALL_DONE pin)	I _{ol} = 4 mA			0.4	V
I _{IH}	Input High Current (PWDN pin)	VIN = 3.6 V, LVCMOS = 3.6 V	−15		15	μA
	Input High Current with internal resistors (4-level input pin)		20		150	

Electrical Characteristics (continued)

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
I _{IL}	Input Low Current (PWDN pin)	VIN = 3.6 V, LVCMOS = 0 V	−15		15	μA
	Input Low Current with internal resistors (4-level input pin)		−160 −40			
CML RECEIVER INPUTS (IN_N+, IN_N-)						
RL _{RX-DIFF}	RX Differential return loss	0.05 - 7.5 GHz	−15			dB
		7.5 - 15 GHz	−5			
RL _{RX-CM}	RX Common mode return loss	0.05 - 5 GHz	−10			dB
Z _{RX-DC}	RX DC common mode impedance	Tested at VDD = 2.5 V	40	50	60	Ω
Z _{RX-DIFF-DC}	RX DC differential mode impedance	Tested at VDD = 2.5 V	80	100	120	Ω
V _{RX-DIFF-DC}	Differential RX peak-to-peak voltage (VID)	Tested at pins	1.2			V
V _{RX-SIGNAL-DET-DIFF-PP}	Signal detect assert level for active data signal	SD_TH = F (float), 0101 pattern at 8 Gbps	180			mVp-p
V _{RX-IDLE-DET-DIFF-PP}	Signal detect deassert level for electrical idle	SD_TH = F (float), 0101 pattern at 8 Gbps	110			mVp-p
HIGH SPEED OUTPUTS						
V _{TX-DIFF-PP}	Output Voltage Differential Swing	Differential measurement with Out_n+ and OUT_n-, terminated by 50 Ω to GND, AC-Coupled, VID = 1 Vp-p, DEM0 = 1, DEM1 = 0 ⁽¹⁾	0.8	1	1.2	Vp-p
V _{TX-DE-RATIO_3.5}	TX de-emphasis ratio	VOD = 1 Vp-p, DEM0 = 0, DEM1 = R, PCIe Gen-1 or PCIe Gen-2 and SAS/SATA (up to 6 Gbps)	−3.5			dB
V _{TX-DE-RATIO_6}	TX de-emphasis ratio	VOD = 1 Vp-p, DEM0 = R, DEM1 = R, PCIe Gen-1 or PCIe Gen-2 and SAS/SATA (up to 6 Gbps)	−6			dB
T _{TX-DJ}	Deterministic Jitter	VID = 800 mV, PRBS15 pattern, 8.0 Gbps, VOD = 1 V, EQ = 0x00, DE = 0 dB, (no input or output trace loss)	0.05			UIpp
T _{TX-RJ}	Random Jitter	VID = 800 mV, 0101 pattern, 8.0 Gbps, VOD = 1 V, EQ = 0x00, DE = 0 dB, (no input or output trace loss)	0.3			ps RMS
T _{TX-RISE-FALL}	Transmitter rise/fall time	20% to 80% of differential output voltage	35	45		ps
T _{RF-MISMATCH}	Transmitter rise/fall mismatch	20% to 80% of differential output voltage	0.01	0.1		UI
RL _{TX-DIFF}	TX Differential return loss	0.05 - 7.5 GHz	−15			dB
		7.5 - 15 GHz	−5			
RL _{TX-CM}	TX Common mode return loss	0.05 - 5 GHz	−10			dB
Z _{TX-DIFF-DC}	DC differential TX impedance		100			Ω
V _{TX-CM-AC-PP}	TX AC common mode voltage	VOD = 1 Vp-p, DEM0 = 1, DEM1 = 0	100			mVp-p
I _{TX-SHORT}	Transmitter short circuit current limit	Total current the transmitter can supply when shorted to VDD or GND	20			mA
V _{TX-CM-DC-ACTIVE-IDLE-DELTA}	Absolute delta of DC common mode voltage during L0 and electrical idle		100			mV
V _{TX-CM-DC-LINE-DELTA}	Absolute delta of DC common mode voltage between TX+ and TX-		25			mV
T _{TX-IDLE-DATA}	Max time to transition to valid differential signal after idle	VID = 1 Vp-p, 8 Gbps	3.5			ns

(1) In PCIe Gen-3 mode, the output VOD level is not fixed. It will be adjusted automatically based on the VID input amplitude level. The output VOD level set by DEMA/B[1:0] in this MODE is dependent on the VID level and the frequency content. The DS125BR401 repeater is designed to be nonlimiting in this MODE, so the TX-FIR (de-emphasis) is passed to the RX to support the handshake negotiation link training.

Electrical Characteristics (continued)

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
T _{TX-DATA-IDLE}	Max time to transition to idle after differential signal	VID = 1 Vp-p, 8 Gbps		6.2		ns
T _{PDEQ}	Differential propagation delay	EQ = 00 ⁽²⁾		200		ps
T _{LSK}	Lane-to-lane skew	T = 25°C, VDD = 2.5 V		25		ps
T _{PPSK}	Part-to-part propagation delay skew	T = 25°C, VDD = 2.5 V		40		ps
EQUALIZATION						
DJE1	Residual deterministic jitter at 12 Gbps	30" 5mils FR4, VID = 0.6 Vp-p, PRBS15, EQ = 0x07, DEM = 0 dB		0.18		Ulpp
DJE2	Residual deterministic jitter at 8 Gbps	30" 5mils FR4, VID = 0.6 Vp-p, PRBS15, EQ = 0x07, DEM = 0 dB		0.11		Ulpp
DJE3	Residual deterministic jitter at 5 Gbps	30" 5mils FR4, VID = 0.6 Vp-p, PRBS15, EQ = 0x07, DEM = 0 dB		0.07		Ulpp
DJE4	Residual deterministic jitter at 12 Gbps	5-meter 30-AWG cable, VID = 0.6 Vp-p, PRBS15, EQ = 0x07, DEM = 0 dB		0.25		Ulpp
DJE5	Residual deterministic jitter at 12 Gbps	8-meter 30-AWG cable, VID = 0.6 Vp-p, PRBS15, EQ = 0x0F, DEM = 0 dB		0.33		Ulpp
DE-EMPHASIS — PCIe Gen-1 or PCIe Gen-2 and SAS/SATA (up to 6 Gbps)						
DJD1	Residual deterministic jitter at 12 Gbps	Input Channel: 20" 5mils FR4, Output Channel: 10" 5mils FR4, VID = 0.6 Vp-p, PRBS15, EQ = 0x03, VOD = 1 Vp-p, DEM = -3.5 dB		0.1		Ulpp

(2) Propagation Delay measurements will change slightly based on the level of EQ selected. EQ = 00 will result in the longest propagation delays.

8.6 Electrical Characteristics — Serial Management Bus Interface

Over recommended operating supply and temperature ranges unless other specified.

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
SERIAL BUS INTERFACE DC SPECIFICATIONS						
V _{IL}	Data, Clock Input Low Voltage				0.8	V
V _{IH}	Data, Clock Input High Voltage		2.1		3.6	V
I _{PULLUP}	Current Through Pullup Resistor or Current Source	High Power Specification	4			mA
V _{DD}	Nominal Bus Voltage		2.375		3.6	V
I _{LEAK-Bus}	Input Leakage Per Bus Segment	See ⁽¹⁾	−200		200	μA
I _{LEAK-Pin}	Input Leakage Per Device Pin			−15		μA
C _I	Capacitance for SDA and SCL	See ⁽¹⁾⁽²⁾			10	pF
R _{TERM}	External Termination Resistance pull to V _{DD} = 2.5 V ± 5% OR 3.3 V ± 10%	Pullup V _{DD} = 3.3 V ⁽¹⁾⁽²⁾⁽³⁾		2000		Ω
		Pullup V _{DD} = 2.5 V ⁽¹⁾⁽²⁾⁽³⁾		1000		
SERIAL BUS INTERFACE TIMING SPECIFICATIONS						
FSMB	Bus Operating Frequency	ENSMB = VDD (Slave Mode)			400	kHz
		ENSMB = FLOAT (Master Mode)	280	400	520	
TBUF	Bus Free Time Between Stop and Start Condition		1.3			μs
THD:STA	Hold time after (Repeated) Start Condition. After this period, the first clock is generated.	At I _{PULLUP} , Max	0.6			μs
TSU:STA	Repeated Start Condition Setup Time		0.6			μs
TSU:STO	Stop Condition Setup Time		0.6			μs
THD:DAT	Data Hold Time		0			ns
TSU:DAT	Data Setup Time		100			ns
T _{LOW}	Clock Low Period		1.3			μs
T _{HIGH}	Clock High Period	See ⁽⁴⁾	0.6		50	μs
t _F	Clock/Data Fall Time	See ⁽⁴⁾			300	ns
t _R	Clock/Data Rise Time	See ⁽⁴⁾			300	ns
t _{POR}	Time in which a device must be operational after power-on reset	See ⁽⁴⁾⁽⁵⁾			500	ms

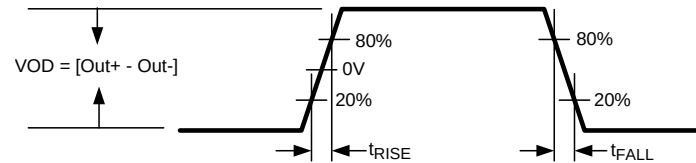
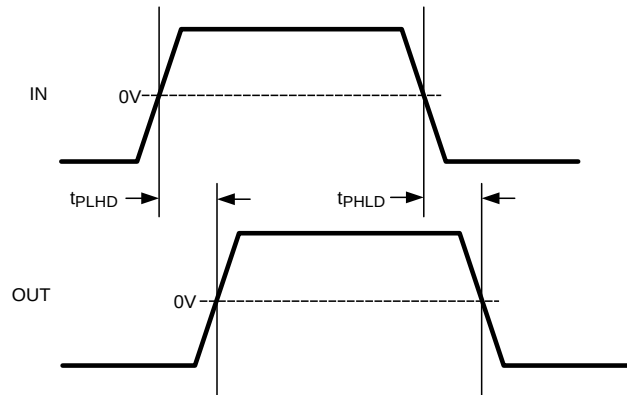
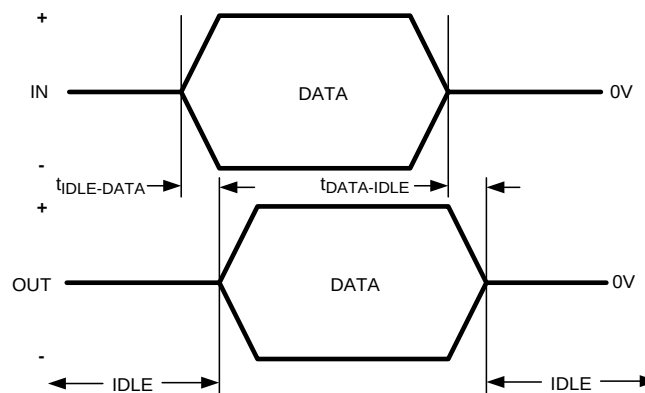
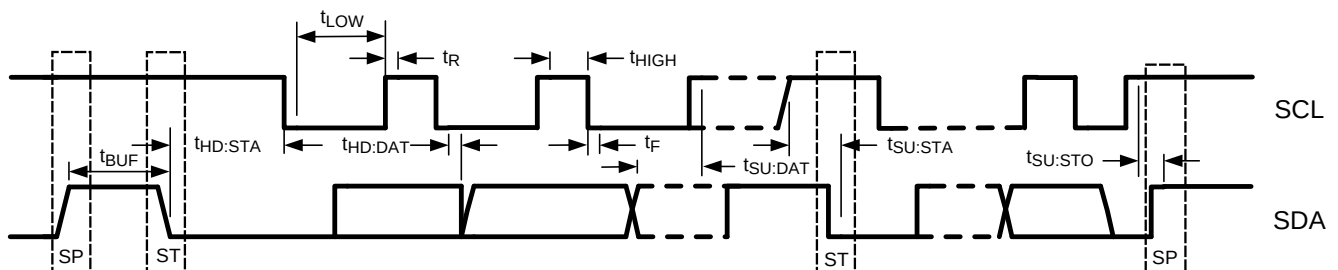
(1) Recommended value.

(2) Recommended maximum capacitance load per bus segment is 400 pF.

(3) Maximum termination voltage should be identical to the device supply voltage.

(4) Compliant to SMBus 2.0 physical layer specification. See System Management Bus (SMBus) Specification Version 2.0, section 3.1.1 SMBus common AC specifications for details.

(5) Ensured by Design. Parameter not tested in production.


Figure 1. CML Output and Rise and FALL Transition Time

Figure 2. Propagation Delay Timing Diagram

Figure 3. Transmit IDLE-DATA and DATA-IDLE Response Time

Figure 4. SMBus Timing Parameters

8.7 Typical Characteristics

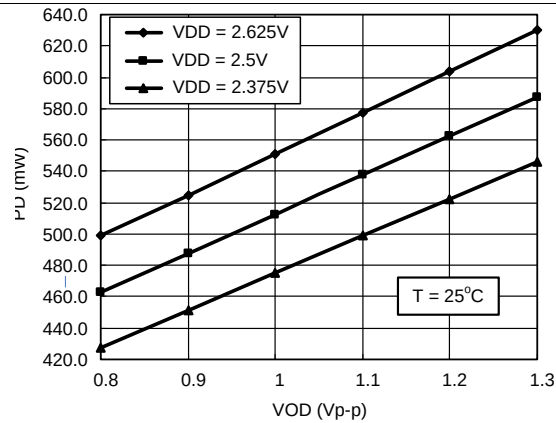


Figure 5. Power Dissipation (PD) vs Output Differential Voltage (VOD)

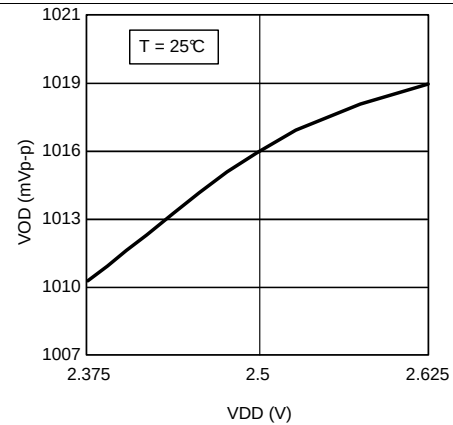


Figure 6. Output Differential Voltage (VOD = 1 Vp-p) vs Supply Voltage (VDD)

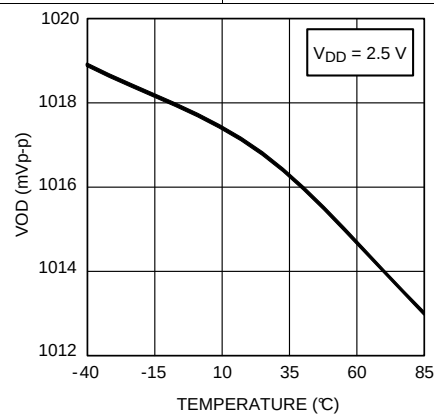


Figure 7. Output Differential Voltage (VOD = 1 Vp-p) vs Temperature

9 Detailed Description

9.1 Overview

The DS125BR401 device compensates for lossy printed-circuit-board (PCB) backplanes and balanced cables.

The DS125BR401 compensates for lossy FR-4 PCB backplanes and balanced cables. The DS125BR401 operates in 3 modes: Pin Control Mode (ENSMB = 0), SMBus Slave Mode (ENSMB = 1) and SMBus Master Mode (ENSMB = float) to load register informations from external EEPROM; refer to [SMBus Master Mode](#) for additional information.

9.2 Functional Block Diagram

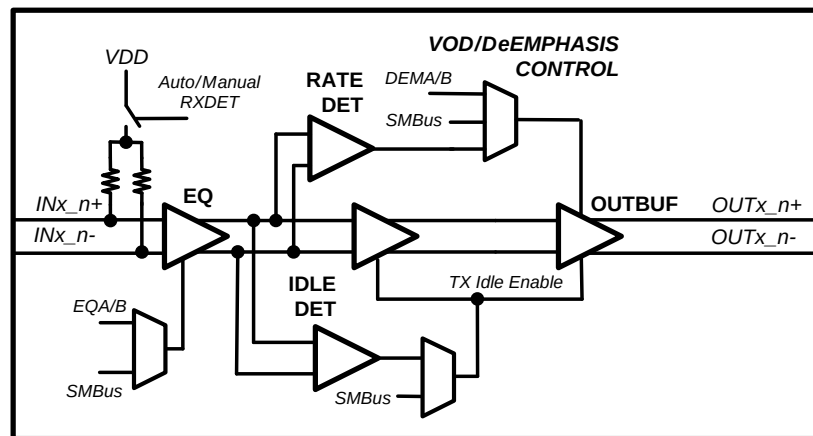


Figure 8. Block Diagram - Detail View Of Channel (1 Of 8)

9.3 Feature Description

The 4-level input pins use a resistor divider to help set the 4 valid levels and provide a wider range of control settings when ENSMB=0. There is an internal 30-kΩ pullup and a 60-kΩ pulldown connected to the package pin. These resistors, together with the external resistor connection combine to achieve the desired voltage level. Using the 1-kΩ pullup, 1-kΩ pulldown, no connect, and 20-kΩ pulldown provide the optimal voltage levels for each of the four input states.

Table 1. 4-Level Control Pin Settings

LEVEL	SETTING	3.3-V MODE	2.5-V MODE
0	Tie 1 kΩ to GND	0.10 V	0.08 V
R	Tie 20 kΩ to GND	$\frac{1}{3} \times V_{IN}$	$\frac{1}{3} \times V_{DD}$
Float	Float (leave pin open)	$\frac{2}{3} \times V_{IN}$	$\frac{2}{3} \times V_{DD}$
1	Tie 1 kΩ to V_{IN} or V_{DD}	$V_{IN} - 0.05 \text{ V}$	$V_{DD} - 0.04 \text{ V}$

9.3.1 Typical 4-Level Input Thresholds

- Level 1 - 2 = $0.2 \times V_{IN}$ or V_{DD}
- Level 2 - 3 = $0.5 \times V_{IN}$ or V_{DD}
- Level 3 - 4 = $0.8 \times V_{IN}$ or V_{DD}

To minimize the start-up current associated with the integrated 2.5-V regulator, TI recommends using the 1-kΩ pullup and pulldown resistors. If several 4-level inputs require the same setting, it is possible to combine two or more 1-kΩ resistors into a single lower value resistor. As an example; combining two inputs with a single 500-Ω resistor is a good way to save board space.

9.4 Device Functional Modes

9.4.1 Pin Control Mode

When in pin mode (ENSMB = 0), equalization and de-emphasis can be selected through pin for each side independently. When de-emphasis is asserted VOD is automatically adjusted per [Table 3](#). For PCIe applications, the RXDET pins provides automatic and manual control for input termination (50 Ω or >50 k Ω). MODE setting is also pin controllable with pin selections (PCIe Gen-1, PCIe Gen-2, auto detect, and PCIe Gen-3). The receiver electrical idle detect threshold is also adjustable through the SD_TH pin.

9.4.2 SMBUS Mode

When in SMBus mode (ENSMB = 1), the VOD (output amplitude), equalization, de-emphasis, and termination disable features are all programmable on a individual lane basis, instead of grouped by A or B as in the pin mode case. Upon assertion of ENSMB, the EQx and DEMx functions revert to register control immediately. The EQx and DEMx pins are converted to AD0-AD3 SMBus address inputs. The other external control pins (MODE, RXDET and SD_TH) remain active unless their respective registers are written to and the appropriate override bit is set, in which case they are ignored until ENSMB is driven low (pin mode). On power up and when ENSMB is driven low all registers are reset to their default state. If PWDN is asserted while ENSMB is high, the registers retain their current state.

Equalization settings accessible through the pin controls were chosen to meet the needs of most high speed applications. If additional fine tuning or adjustment is needed, additional equalization settings can be accessed through the SMBus registers. Each input has a total of 256 possible equalization settings. [System Management Bus \(SMBus\) and Configuration Registers](#) show the 16 setting when the device is in pin mode. When using SMBus mode, the equalization, VOD and de-emphasis levels are set by registers.

9.5 Programming

9.5.1 PCIe Signal Integrity

When using the DS125BR401 in PCIe Gen-3 systems, there are specific signal integrity settings to ensure signal integrity margin. The settings were optimized by extensive testing. Contact your field representative for more information regarding the testing completed to achieve these settings.

For tuning the in the downstream direction (from CPU to EP).

- EQ: use the guidelines outlined in [Table 2](#).
- De-Emphasis: use the guidelines outlined in [Table 3](#).
- VOD: use the guidelines outlined in [Table 3](#).

For tuning in the upstream direction (from EP to CPU).

- EQ: use the guidelines outlined in [Table 2](#).
- De-Emphasis:
 - For trace lengths < 15 in set to –3.5 dB
 - For trace lengths > 15 in set to –6 dB
- VOD: set to 900 mV

Programming (continued)
Table 2. Equalizer Settings

LEVEL	EQA1 EQB1	EQA0 EQB	EQ – 8 bits [7:0]	dB at 1.5 GHz	dB at 2.5 GHz	dB at 4 GHz	dB at 6 GHz	SUGGESTED USE ⁽¹⁾
1	0	0	0000 0000 = 0x00	2.5	3.5	3.8	3.1	FR4 < 5-inch trace
2	0	R	0000 0001 = 0x01	3.8	5.4	6.7	6.7	FR4 5- to 10-inch trace
3	0	Float	0000 0010 = 0x02	5	7	8.4	8.4	FR4 10-inch trace
4	0	1	0000 0011 = 0x03	5.9	8	9.3	9.1	FR4 15- to 20-inch trace
5	R	0	0000 0111 = 0x07	7.4	10.3	12.8	13.7	FR4 20- to 30-inch trace
6	R	R	0001 0101 = 0x15	6.9	10.2	13.9	16.2	FR4 25- to 30-inch trace
7	R	Float	0000 1011 = 0x0B	9	12.4	15.3	15.9	FR4 25- to 30-inch trace
8	R	1	0000 1111 = 0x0F	10.2	13.8	16.7	17	8-m, 30-AWG cable
9	Float	0	0101 0101 = 0x55	8.5	12.6	17.5	20.7	> 8-m cable
10	Float	R	0001 1111 = 0x1F	11.7	16.2	20.3	21.8	
11	Float	Float	0010 1111 = 0x2F	13.2	18.3	22.8	23.6	
12	Float	1	0011 1111 = 0x3F	14.4	19.8	24.2	24.7	
13	1	0	1010 1010 = 0xAA	14.4	20.5	26.4	28	
14	1	R	0111 1111 = 0x7F	16	22.2	27.8	29.2	
15	1	Float	1011 1111 = 0xBF	17.6	24.4	30.2	30.9	
16	1	1	1111 1111 = 0xFF	18.7	25.8	31.6	31.9	

- (1) Cable and FR4 lengths are for reference only. FR4 lengths based on a 100-Ω differential stripline with 5-mil traces and 8-mil trace separation. Optimal EQ setting should be determined through simulation and prototype verification.

Table 3. Output Voltage and De-Emphasis Settings

LEVEL	DEMA1 DEMB1	DEMA0 DEMB0	VOD Vp-p	DEM dB ⁽¹⁾	INNER AMPLITUDE Vp-p	SUGGESTED USE ⁽²⁾
1	0	0	0.8	0	0.8	FR4 <5-inch trace
2	0	R	0.9	0	0.9	FR4 <5-inch trace
3	0	Float	0.9	–3.5	0.6	FR4 10-inch trace
4	0	1	1	0	1	FR4 <5-inch trace
5	R	0	1	–3.5	0.7	FR4 10-inch trace
6	R	R	1	–6	0.5	FR4 15-inch trace
7	R	Float	1.1	0	1.1	FR4 <5-inch trace
8	R	1	1.1	–3.5	0.7	FR4 10-inch trace
9	Float	0	1.1	–6	0.6	FR4 15-inch trace
10	Float	R	1.2	0	1.2	FR4 <5-inch trace
11	Float	Float	1.2	–3.5	0.8	FR4 10-inch trace
12	Float	1	1.2	–6	0.6	FR4 15-inch trace
13	1	0	1.3	0	1.3	FR4 <5-inch trace
14	1	R	1.3	–3.5	0.9	FR4 10-inch trace
15	1	Float	1.3	–6	0.7	FR4 15-inch trace
16	1	1	1.3	–9	0.5	FR4 20-inch trace

- (1) The VOD output amplitude and DEM de-emphasis levels are set with the DEMA/B[1:0] pins. The de-emphasis levels are also available in PCIe Gen-3 mode when MODE = 1 (tied to VDD).
- (2) FR4 lengths are for reference only. FR4 lengths based on a 100-Ω differential stripline with 5-mil traces and 8-mil trace separation. Optimal DEM settings should be determined through simulation and prototype verification.

Table 4. RX-Detect Settings

PWDN (PIN 52)	RXDET (PIN 22)	SMBus REG bit[3:2]	INPUT TERMINATION	RECOMMENDED USE	COMMENTS
0	0	00	Hi-Z	X	Manual RX-Detect, input is high impedance mode
0	Tie 20 kΩ to GND	01	Pre Detect: Hi-Z Post Detect: 50 Ω	PCIe only	Auto RX-Detect, outputs test every 12 msec for 600 msec then stops; termination is Hi-Z until RX detection; once detected input termination is 50 Ω Reset function by pulsing PWDN high for 5 usec then low again
0	Float (Default)	10	Pre Detect: Hi-Z Post Detect: 50 Ω	PCIe only	Auto RX-Detect, outputs test every 12 msec until detection occurs; termination is Hi-Z until RX detection; once detected input termination is 50 Ω
0	1	11	50 Ω	All Others	Manual RX-Detect, input is 50 Ω
1	X		High Impedance	X	Power-down mode, input is Hi-Z, output drivers are disabled Used to reset RX-Detect State Machine when held high for 5 usec

9.5.1.1 RX-Detect in SAS/SATA (up to 6 Gbps) Applications

Unlike PCIe systems, SAS/SATA (up to 6 Gbps) systems use a low speed Out-Of-Band or OOB communications sequence to detect and communicate between Controllers/Expanders and target drives. This communication eliminates the need to detect for endpoints like PCIe. For SAS/SATA systems, TI recommends tying the RXDET pin high. This will ensure any OOB sequences sent from the Controller/Expander will reach the target drive without any additional latency due to the termination detection sequence defined by PCIe.

Table 5. Signal Detect Threshold Level⁽¹⁾

SD_TH (PIN 26)	SMBus REG bit [3:2] and [1:0]	ASSERT LEVEL (TYP)	DEASSERT LEVEL (TYP)
0	10	210 mVp-p	150 mVp-p
R	01	160 mVp-p	100 mVp-p
F (default)	00	180 mVp-p	110 mVp-p
1	11	190 mVp-p	130 mVp-p

(1) VDD = 2.5V, 25°C and 0101 pattern at 8 Gbps

9.5.1.1.1 Signal Detect Control for Datarates Above 8 Gbps

Signal detect bandwidth limitations combined with high levels of signal attenuation can result in intermittent data loss above 8 Gbps. This data loss can be eliminated by disabling automatic detection and forcing the Signal Detect function to be always "on". This programming requires SMBus control over the DS125BR401 to be present. The Signal Detect function is controlled for each channel independently. The register programming sequence is shown below:

1. Write register 0x06 = 0x18 /* Enable SMBus register programming
2. Write registers 0x0D[1] = 1'b, 0x14[1] = 1'b, 0x1B[1] = 1'b, 0x22[1] = 1'b /* CH0 - CH3
3. Write registers 0x2A[1] = 1'b, 0x31[1] = 1'b, 0x38[1] = 1'b, 0x3F[1] = 1'b /* CH4 - CH7

Table 6. MODE Operation with Pin Control

MODE (PIN 21)	Driver Characteristics	PCIe	SAS SATA	10G-KR	10GbE	CPRI OBSAI	SRIO (R)XAUI	Interlaken Infiniband
0	Limiting		X		X	X	X	X
R	Nonlimiting without DE							
F (default)	Automatic	X						
1	Nonlimiting with DE			X				

Note: Automatic operation allows input to sense the incoming data rate and use a Nonlimiting output driver for operation at or above 8 Gbps.

Note: SAS/SATA up to 6 Gbps.

9.5.1.2 MODE Operation With SMBus Registers

When in SMBus mode (Slave or Master), the MODE pin retains control of the output driver characteristics. In order to override this control function, Register 0x08[2] must be written with a "1". Writing this bit enables MODE control of each channel individually using the channel registers defined in [Table 7](#).

DS125BR401

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Table 7. EEPROM Register Map - Single Device With Default Value

EEPROM Address Byte		Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0
Description	0x00	CRC EN	Address Map Present	EEPROM > 256 Bytes	Reserved	DEVICE COUNT[3]	DEVICE COUNT[2]	DEVICE COUNT[1]	DEVICE COUNT[0]
Default Value	0x00	0	0	0	0	0	0	0	0
Description	0x01	Reserved	Reserved	Reserved	Reserved	Reserved	Reserved	Reserved	Reserved
Default Value	0x00	0	0	0	0	0	0	0	0
Description	0x02	Max EEPROM Burst size[7]	Max EEPROM Burst size[6]	Max EEPROM Burst size[5]	Max EEPROM Burst size[4]	Max EEPROM Burst size[3]	Max EEPROM Burst size[2]	Max EEPROM Burst size[1]	Max EEPROM Burst size[0]
Default Value	0x00	0	0	0	0	0	0	0	0
Description	0x03	PWDN_ch7	PWDN_ch6	PWDN_ch5	PWDN_ch4	PWDN_ch3	PWDN_ch2	PWDN_ch1	PWDN_ch0
SMBus Register		0x01 [7]	0x01 [6]	0x01 [5]	0x01 [4]	0x01 [3]	0x01 [2]	0x01 [1]	0x01 [0]
Default Value	0x00	0	0	0	0	0	0	0	0
Description	0x04	lpbk_1	lpbk_0	PWDN_INPUTS	PWDN_OSC	Ovrd_PWDN	Reserved	Reserved	Reserved
SMBus Register		0x02 [5]	0x02 [4]	0x02 [3]	0x02 [2]	0x02 [0]	0x04 [7]	0x04 [6]	0x04 [5]
Default Value	00	0	0	0	0	0	0	0	0
Description	0x05	Reserved	Reserved	Reserved	Reserved	Reserved	rxdet_bt看_en	Ovrd_idle_th	Ovrd_RES
SMBus Register		0x04 [4]	0x04 [3]	0x04 [2]	0x04 [1]	0x04 [0]	0x06 [4]	0x08 [6]	0x08 [5]
Default Value	04	0	0	0	0	0	1	0	0
Description	0x06	Ovrd_IDLE	Ovrd_RX_DET	Ovrd_MODE	Ovrd_RES	Ovrd_RES	rx_delay_sel_2	rx_delay_sel_1	rx_delay_sel_0
SMBus Register		0x08 [4]	0x08 [3]	0x08 [2]	0x08 [1]	0x08 [0]	0x0B [6]	0x0B [5]	0x0B [4]
Default Value	07	0	0	0	0	0	1	1	1
Description	0x07	RD_delay_sel_3	RD_delay_sel_2	RD_delay_sel_1	RD_delay_sel_0	ch0_idle_auto	ch0_idle_sel	ch0_RXDET_1	ch0_RXDET_0
SMBus Register		0x0B [3]	0x0B [2]	0x0B [1]	0x0B [0]	0x0E [5]	0x0E [4]	0x0E [3]	0x0E [2]
Default Value	00	0	0	0	0	0	0	0	0
Description	0x08	ch0_BST_7	ch0_BST_6	ch0_BST_5	ch0_BST_4	ch0_BST_3	ch0_BST_2	ch0_BST_1	ch0_BST_0
SMBus Register		0x0F [7]	0x0F [6]	0x0F [5]	0x0F [4]	0x0F [3]	0x0F [2]	0x0F [1]	0x0F [0]
Default Value	2F	0	0	1	0	1	1	1	1
Description	0x09	ch0_Sel_scp	ch0_Sel_mode	ch0_RES_2	ch0_RES_1	ch0_RES_0	ch0_VOD_2	ch0_VOD_1	ch0_VOD_0
SMBus Register		0x10 [7]	0x10 [6]	0x10 [5]	0x10 [4]	0x10 [3]	0x10 [2]	0x10 [1]	0x10 [0]
Default Value	AD	1	0	1	0	1	1	0	1
Description	0x0A	ch0_DEM_2	ch0_DEM_1	ch0_DEM_0	ch0_Slow	ch0_idle_tha_1	ch0_idle_tha_0	ch0_idle_thd_1	ch0_idle_thd_0
SMBus Register		0x11 [2]	0x11 [1]	0x11 [0]	0x12 [7]	0x12 [3]	0x12 [2]	0x12 [1]	0x12 [0]
Default Value	40	0	1	0	0	0	0	0	0

Table 7. EEPROM Register Map - Single Device With Default Value (continued)

EEPROM Address Byte		Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0
Description	0x0B	ch1_idle_auto	ch1_idle_sel	ch1_RXDET_1	ch1_RXDET_0	ch1_BST_7	ch1_BST_6	ch1_BST_5	ch1_BST_4
SMBus Register		0x15 [5]	0x15 [4]	0x15 [3]	0x15 [2]	0x16 [7]	0x16 [6]	0x16 [5]	0x16 [4]
Default Value		0	0	0	0	0	0	1	0
Description	0x0C	ch1_BST_3	ch1_BST_2	ch1_BST_1	ch1_BST_0	ch1_Sel_scp	ch1_Sel_mode	ch1_RES_2	ch1_RES_1
SMBus Register		0x16 [3]	0x16 [2]	0x16 [1]	0x16 [0]	0x17 [7]	0x17 [6]	0x17 [5]	0x17 [4]
Default Value		1	1	1	1	1	0	1	0
Description	0x0D	ch1_RES_0	ch1_VOD_2	ch1_VOD_1	ch1_VOD_0	ch1_DEM_2	ch1_DEM_1	ch1_DEM_0	ch1_Slow
SMBus Register		0x17 [3]	0x17 [2]	0x17 [1]	0x17 [0]	0x18 [2]	0x18 [1]	0x18 [0]	0x19 [7]
Default Value		1	1	0	1	0	1	0	0
Description	0x0E	ch1_idle_tha_1	ch1_idle_tha_0	ch1_idle_thd_1	ch1_idle_thd_0	ch2_Idle_auto	ch2_Idle_sel	ch2_RXDET_1	ch2_RXDET_0
SMBus Register		0x19 [3]	0x19 [2]	0x19 [1]	0x19 [0]	0x1C [5]	0x1C [4]	0x1C [3]	0x1C [2]
Default Value		0	0	0	0	0	0	0	0
Description	0x0F	ch2_BST_7	ch2_BST_6	ch2_BST_5	ch2_BST_4	ch2_BST_3	ch2_BST_2	ch2_BST_1	ch2_BST_0
SMBus Register		0x1D [7]	0x1D [6]	0x1D [5]	0x1D [4]	0x1D [3]	0x1D [2]	0x1D [1]	0x1D [0]
Default Value		0	0	1	0	1	1	1	1
Description	0x10	ch2_Sel_scp	ch2_Sel_mode	ch2_RES_2	ch2_RES_1	ch2_RES_0	ch2_VOD_2	ch2_VOD_1	ch2_VOD_0
SMBus Register		0x1E [7]	0x1E [6]	0x1E [5]	0x1E [4]	0x1E [3]	0x1E [2]	0x1E [1]	0x1E [0]
Default Value		1	0	1	0	1	1	0	1
Description	0x11	ch2_DEM_2	ch2_DEM_1	ch2_DEM_0	ch2_Slow	ch2_idle_tha_1	ch2_idle_tha_0	ch2_idle_thd_1	ch2_idle_thd_0
SMBus Register		0x1F [2]	0x1F [1]	0x1F [0]	0x20 [7]	0x20 [3]	0x20 [2]	0x20 [1]	0x20 [0]
Default Value		0	1	0	0	0	0	0	0
Description	0x12	ch3_Idle_auto	ch3_Idle_sel	ch3_RXDET_1	ch3_RXDET_0	ch3_BST_7	ch3_BST_6	ch3_BST_5	ch3_BST_4
SMBus Register		0x23 [5]	0x23 [4]	0x23 [3]	0x23 [2]	0x24 [7]	0x24 [6]	0x24 [5]	0x24 [4]
Default Value		0	0	0	0	0	0	1	0
Description	0x13	ch3_BST_3	ch3_BST_2	ch3_BST_1	ch3_BST_0	ch3_Sel_scp	ch3_Sel_mode	ch3_RES_2	ch3_RES_1
SMBus Register		0x24 [3]	0x24 [2]	0x24 [1]	0x24 [0]	0x25 [7]	0x25 [6]	0x25 [5]	0x25 [4]
Default Value		1	1	1	1	1	0	1	0
Description	0x14	ch3_RES_0	ch3_VOD_2	ch3_VOD_1	ch3_VOD_0	ch3_DEM_2	ch3_DEM_1	ch3_DEM_0	ch3_Slow
SMBus Register		0x25 [3]	0x25 [2]	0x25 [1]	0x25 [0]	0x26 [2]	0x26 [1]	0x26 [0]	0x27 [7]
Default Value		1	1	0	1	0	1	0	0
Description	0x15	ch3_idle_tha_1	ch3_idle_tha_0	ch3_idle_thd_1	ch3_idle_thd_0	ovrd_fast_idle	en_high_idle_th_n	en_high_idle_th_s	en_fast_idle_n
SMBus Register		0x27 [3]	0x27 [2]	0x27 [1]	0x27 [0]	0x28 [6]	0x28 [5]	0x28 [4]	0x28 [3]
Default Value		0	0	0	0	0	0	0	1

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Table 7. EEPROM Register Map - Single Device With Default Value (continued)

EEPROM Address Byte		Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0
Description	0x16	en_fast_idle_s	eqsd_mgain_n	eqsd_mgain_s	ch4_idle_auto	ch4_idle_sel	ch4_RXDET_1	ch4_RXDET_0	ch4_BST_7
SMBus Register		0x28 [2]	0x28 [1]	0x28 [0]	0x2B [5]	0x2B [4]	0x2B [3]	0x2B [2]	0x2C [7]
Default Value		80	1	0	0	0	0	0	0
Description	0x17	ch4_BST_6	ch4_BST_5	ch4_BST_4	ch4_BST_3	ch4_BST_2	ch4_BST_1	ch4_BST_0	ch4_Sel_scp
SMBus Register		0x2C [6]	0x2C [5]	0x2C [4]	0x2C [3]	0x2C [2]	0x2C [1]	0x2C [0]	0x2D [7]
Default Value		5F	0	1	0	1	1	1	1
Description	0x18	ch4_Sel_mode	ch4_RES_2	ch4_RES_1	ch4_RES_0	ch4_VOD_2	ch4_VOD_1	ch4_VOD_0	ch4_DEM_2
SMBus Register		0x2D [6]	0x2D [5]	0x2D [4]	0x2D [3]	0x2D [2]	0x2D [1]	0x2D [0]	0x2E [2]
Default Value		5A	0	1	0	1	0	1	0
Description	0x19	ch4_DEM_1	ch4_DEM_0	ch4_Slow	ch4_idle_tha_1	ch4_idle_tha_0	ch4_idle_thd_1	ch4_idle_thd_0	ch5_Idle_auto
SMBus Register		0x2E [1]	0x2E [0]	0x2F [7]	0x2F [3]	0x2F [2]	0x2F [1]	0x2F [0]	0x32 [5]
Default Value		80	1	0	0	0	0	0	0
Description	0x1A	ch5_Idle_sel	ch5_RXDET_1	ch5_RXDET_0	ch5_BST_7	ch5_BST_6	ch5_BST_5	ch5_BST_4	ch5_BST_3
SMBus Register		0x32 [4]	0x32 [3]	0x32 [2]	0x33 [7]	0x33 [6]	0x33 [5]	0x33 [4]	0x33 [3]
Default Value		05	0	0	0	0	1	0	1
Description	0x1B	ch5_BST_2	ch5_BST_1	ch5_BST_0	ch5_Sel_scp	ch5_Sel_mode	ch5_RES_2	ch5_RES_1	ch5_RES_0
SMBus Register		0x33 [2]	0x33 [1]	0x33 [0]	0x34 [7]	0x34 [6]	0x34 [5]	0x34 [4]	0x34 [3]
Default Value		F5	1	1	1	0	1	0	1
Description	0x1C	ch5_VOD_2	ch5_VOD_1	ch5_VOD_0	ch5_DEM_2	ch5_DEM_1	ch5_DEM_0	ch5_Slow	ch5_idle_tha_1
SMBus Register		0x34 [2]	0x34 [1]	0x34 [0]	0x35 [2]	0x35 [1]	0x35 [0]	0x36 [7]	0x36 [3]
Default Value		A8	1	0	1	0	1	0	0
Description	0x1D	ch5_idle_tha_0	ch5_idle_thd_1	ch5_idle_thd_0	ch6_Idle_auto	ch6_Idle_sel	ch6_RXDET_1	ch6_RXDET_0	ch6_BST_7
SMBus Register		0x36 [2]	0x36 [1]	0x36 [0]	0x39 [5]	0x39 [4]	0x39 [3]	0x39 [2]	0x3A [7]
Default Value		00	0	0	0	0	0	0	0
Description	0x1E	ch6_BST_6	ch6_BST_5	ch6_BST_4	ch6_BST_3	ch6_BST_2	ch6_BST_1	ch6_BST_0	ch6_Sel_scp
SMBus Register		0x3A [6]	0x3A [5]	0x3A [4]	0x3A [3]	0x3A [2]	0x3A [1]	0x3A [0]	0x3B [7]
Default Value		5F	0	1	0	1	1	1	1
Description	0x1F	ch6_Sel_mode	ch6_RES_2	ch6_RES_1	ch6_RES_0	ch6_VOD_2	ch6_VOD_1	ch6_VOD_0	ch6_DEM_2
SMBus Register		0x3B [6]	0x3B [5]	0x3B [4]	0x3B [3]	0x3B [2]	0x3B [1]	0x3B [0]	0x3C [2]
Default Value		5A	0	1	0	1	0	1	0
Description	0x20	ch6_DEM_1	ch6_DEM_0	ch6_Slow	ch6_idle_tha_1	ch6_idle_tha_0	ch6_idle_thd_1	ch6_idle_thd_0	ch7_Idle_auto
SMBus Register		0x3C [1]	0x3C [0]	0x3D [7]	0x3D [3]	0x3D [2]	0x3D [1]	0x3D [0]	0x40 [5]
Default Value		80	1	0	0	0	0	0	0

Table 7. EEPROM Register Map - Single Device With Default Value (continued)

EEPROM Address Byte		Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0
Description	0x21	ch7_idle_sel	ch7_RXDET_1	ch7_RXDET_0	ch7_BST_7	ch7_BST_6	ch7_BST_5	ch7_BST_4	ch7_BST_3
SMBus Register		0x40 [4]	0x40 [3]	0x40 [2]	0x41 [7]	0x41 [6]	0x41 [5]	0x41 [4]	0x41 [3]
Default Value		0	0	0	0	0	1	0	1
Description	0x22	ch7_BST_2	ch7_BST_1	ch7_BST_0	ch7_Sel_scp	ch7_Sel_mode	ch7_RES_2	ch7_RES_1	ch7_RES_0
SMBus Register		0x41 [2]	0x41 [1]	0x41 [0]	0x42 [7]	0x42 [6]	0x42 [5]	0x42 [4]	0x42 [3]
Default Value		1	1	1	1	0	1	0	1
Description	0x23	ch7_VOD_2	ch7_VOD_1	ch7_VOD_0	ch7_DEM_2	ch7_DEM_1	ch7_DEM_0	ch7_Slow	ch7_idle_tha_1
SMBus Register		0x42 [2]	0x42 [1]	0x42 [0]	0x43 [2]	0x43 [1]	0x43 [0]	0x44 [7]	0x44 [3]
Default Value		1	0	1	0	1	0	0	0
Description	0x24	ch7_idle_tha_0	ch7_idle_thd_1	ch7_idle_thd_0	Reserved	Reserved	Reserved	Reserved	Reserved
SMBus Register		0x44 [2]	0x44 [1]	0x44 [0]	0x47 [3]	0x47 [2]	0x47 [2]	0x47 [0]	0x48 [7]
Default Value		0	0	0	0	0	0	0	0
Description	0x25	Reserved	Reserved	Reserved	Reserved	Reserved	Reserved	Reserved	Reserved
SMBus Register		0x48 [6]	0x4C [7]	0x4C [6]	0x4C [5]	0x4C [4]	0x4C [3]	0x4C [0]	0x59 [0]
Default Value		0	0	0	0	0	0	0	0
Description	0x26	Reserved	Reserved	Reserved	Reserved	Reserved	Reserved	Reserved	Reserved
SMBus Register		0x5A [7]	0x5A [6]	0x5A [5]	0x5A [4]	0x5A [3]	0x5A [2]	0x5A [1]	0x5A [0]
Default Value		0	1	0	1	0	1	0	0
Description	0x27	Reserved	Reserved	Reserved	Reserved	Reserved	Reserved	Reserved	Reserved
SMBus Register		0x5B [7]	0x5B [6]	0x5B [5]	0x5B [4]	0x5B [3]	0x5B [2]	0x5B [1]	0x5B [0]
Default Value		0	1	0	1	0	1	0	0

Table 8. Example of EEPROM for Four Devices Using Two Address Maps

EEPROM Address	Address (Hex)	EEPROM Data	Comments
0	00	0x43	CRC_EN = 0, Address Map = 1, >256 bytes = 0, Device Count[3:0] = 3
1	01	0x00	
2	02	0x08	EEPROM Burst Size
3	03	0x00	CRC not used
4	04	0x0B	Device 0 Address Location
5	05	0x00	CRC not used
6	06	0x0B	Device 1 Address Location
7	07	0x00	CRC not used
8	08	0x30	Device 2 Address Location
9	09	0x00	CRC not used
10	0A	0x30	Device 3 Address Location
11	0B	0x00	Begin Device 0, 1 - Address Offset 3
12	0C	0x00	
13	0D	0x04	
14	0E	0x07	
15	0F	0x00	
16	10	0x00	EQ CHB0 = 00
17	11	0xAB	VOD CHB0 = 1 V
18	12	0x00	DEM CHB0 = 0 (0 dB)
19	13	0x00	EQ CHB1 = 00
20	14	0x0A	VOD CHB1 = 1 V
21	15	0xB0	DEM CHB1 = 0 (0 dB)
22	16	0x00	
23	17	0x00	EQ CHB2 = 00
24	18	0xAB	VOD CHB2 = 1 V
25	19	0x00	DEM CHB2 = 0 (0 dB)
26	1A	0x00	EQ CHB3 = 00
27	1B	0x0A	VOD CHB3 = 1 V
28	1C	0xB0	DEM CHB3 = 0 (0 dB)
29	1D	0x01	
30	1E	0x80	
31	1F	0x01	EQ CHA0 = 00
32	20	0x56	VOD CHA0 = 1 V
33	21	0x00	DEM CHA0 = 0 (0 dB)
34	22	0x00	EQ CHA1 = 00
35	23	0x15	VOD CHA1 = 1 V
36	24	0x60	DEM CHA1 = 0 (0 dB)
37	25	0x00	
38	26	0x01	EQ CHA2 = 00
39	27	0x56	VOD CHA2 = 1 V
40	28	0x00	DEM CHA2 = 0 (0 dB)
41	29	0x00	EQ CHA3 = 00
42	2A	0x15	VOD CHA3 = 1 V
43	2B	0x60	DEM CHA3 = 0 (0 dB)
44	2C	0x00	
45	2D	0x00	
46	2E	0x54	

Table 8. Example of EEPROM for Four Devices Using Two Address Maps (continued)

EEPROM Address	Address (Hex)	EEPROM Data	Comments
47	2F	0x54	End Device 0, 1 - Address Offset 39
48	30	0x00	Begin Device 2, 3 - Address Offset 3
49	31	0x00	
50	32	0x04	
51	33	0x07	
52	34	0x00	
53	35	0x00	EQ CHB0 = 00
54	36	0xAB	VOD CHB0 = 1 V
55	37	0x00	DEM CHB0 = 0 (0 dB)
56	38	0x00	EQ CHB1 = 00
57	39	0x0A	VOD CHB1 = 1 V
58	3A	0xB0	DEM CHB1 = 0 (0 dB)
59	3B	0x00	
60	3C	0x00	EQ CHB2 = 00
61	3D	0xAB	VOD CHB2 = 1 V
62	3E	0x00	DEM CHB2 = 0 (0 dB)
63	3F	0x00	EQ CHB3 = 00
64	40	0x0A	VOD CHB3 = 1 V
65	41	0xB0	DEM CHB3 = 0 (0 dB)
66	42	0x01	
67	43	0x80	
68	44	0x01	EQ CHA0 = 00
69	45	0x56	VOD CHA0 = 1 V
70	46	0x00	DEM CHA0 = 0 (0 dB)
71	47	0x00	EQ CHA1 = 00
72	48	0x15	VOD CHA1 = 1 V
73	49	0x60	DEM CHA1 = 0 (0 dB)
74	4A	0x00	
75	4B	0x01	EQ CHA2 = 00
76	4C	0x56	VOD CHA2 = 1 V
77	4D	0x00	DEM CHA2 = 0 (0 dB)
78	4E	0x00	EQ CHA3 = 00
79	4F	0x15	VOD CHA3 = 1 V
80	50	0x60	DEM CHA3 = 0 (0 dB)
81	51	0x00	
82	52	0x00	
83	53	0x54	
84	54	0x54	End Device 2, 3 - Address Offset 39

Note: CRC_EN = 0, Address Map = 1, >256 byte = 0, Device Count[3:0] = 3. This example has all eight channels set to EQ = 00 (min boost), VOD = 1 V, DEM = 0 (0 dB) and multiple device can point to the same address map. Maximum EEPROM size is 8Kb (1024 × 8 bits).

9.5.3 System Management Bus (SMBus) and Configuration Registers

The System Management Bus interface is compatible to SMBus 2.0 physical layer specification. ENSMB = 1 k Ω to VDD to enable SMBus slave mode and allow access to the configuration registers.

The DS125BR401 has the AD[3:0] inputs in SMBus mode. These pins are the user set SMBUS slave address inputs. The AD[3:0] pins have internal pulldown. When left floating or pulled low the AD[3:0] = 0000'b, the device default address byte is 0xB0. Based on the SMBus 2.0 specification, the DS125BR401 has a 7-bit slave address. The LSB is set to 0'b (for a WRITE). The device supports up to 16 address byte, which can be set with the AD[3:0] inputs. [Table 9](#) shows the 16 addresses.

Table 9. Device Slave Address Bytes

AD[3:0] Settings	Address Bytes (HEX)
0000	B0
0001	B2
0010	B4
0011	B6
0100	B8
0101	BA
0110	BC
0111	BE
1000	C0
1001	C2
1010	C4
1011	C6
1100	C8
1101	CA
1110	CC
1111	CE

The SDA, SCL pins are 3.3-V tolerant, but are not 5-V tolerant. External pullup resistor is required on the SDA. The resistor value can be from 1 k Ω to 5 k Ω depending on the voltage, loading and speed. The SCL may also require an external pullup resistor and it depends on the Host that drives the bus.

9.5.3.1 Transfer of Data Through the SMBus

During normal operation the data on SDA must be stable during the time when SCL is High.

There are three unique states for the SMBus:

START: A High-to-Low transition on SDA while SCL is High indicates a message START condition.

STOP: A Low-to-High transition on SDA while SCL is High indicates a message STOP condition.

IDLE: If SCL and SDA are both High for a time exceeding t_{BUF} from the last detected STOP condition or if they are High for a total exceeding the maximum specification for t_{HIGH} then the bus will transfer to the IDLE state.

9.5.3.2 SMBus Transactions

The device supports WRITE and READ transactions. See [Table 10](#) for register address, type (Read/Write, Read Only), default value and function information.

9.5.3.3 Writing a Register

To write a register, the following protocol is used (see SMBus 2.0 specification).

1. The Host drives a START condition, the 7-bit SMBus address, and a "0" indicating a WRITE.
2. The Device (Slave) drives the ACK bit ("0").
3. The Host drives the 8-bit Register Address.
4. The Device drives an ACK bit ("0").

5. The Host drive the 8-bit data byte.
6. The Device drives an ACK bit ("0").
7. The Host drives a STOP condition.

The WRITE transaction is completed, the bus goes IDLE and communication with other SMBus devices may now occur.

9.5.3.4 Reading a Register

To read a register, the following protocol is used (see SMBus 2.0 specification).

1. The Host drives a START condition, the 7-bit SMBus address, and a 0 indicating a WRITE.
2. The Device (Slave) drives the ACK bit (0).
3. The Host drives the 8-bit Register Address.
4. The Device drives an ACK bit (0).
5. The Host drives a START condition.
6. The Host drives the 7-bit SMBus Address, and a 1 indicating a READ.
7. The Device drives an ACK bit 0.
8. The Device drives the 8-bit data value (register contents).
9. The Host drives a NACK bit 1 indicating end of the READ transfer.
10. The Host drives a STOP condition.

The READ transaction is completed, the bus goes IDLE and communication with other SMBus devices may now occur.

See [Table 10](#) for more information.

9.6 Register Maps

Table 10. SMBUS Slave Mode Register Map

Address	Register Name	Bit	Field	Type	Default	EEPROM Bit	Description
0x00	Device Address Observation	7	Reserved	R/W	0x00		Set bit to 0.
		6:3	Address Bit AD[3:0]	R			Observation of AD[3:0] bits [6]: AD3 [5]: AD2 [4]: AD1 [3]: AD0
		2	EEPROM Read Done	R			1: Device completed the read from external EEPROM.
		1:0	Reserved	R/W			Set bits to 0.
0x01	PWDN Channels	7:0	PWDN CHx	R/W	0x00	Yes	Power Down per Channel [7]: CH7 – CHA_3 [6]: CH6 – CHA_2 [5]: CH5 – CHA_1 [4]: CH4 – CHA_0 [3]: CH3 – CHB_3 [2]: CH2 – CHB_2 [1]: CH1 – CHB_1 [0]: CH0 – CHB_0 0x00 = all channels enabled 0xFF = all channels disabled Note: override PWDN pin.

Register Maps (continued)
Table 10. SMBUS Slave Mode Register Map (continued)

Address	Register Name	Bit	Field	Type	Default	EEPROM Bit	Description
0x02	Override PWDN, LPBK Control	7:6	Reserved	R/W	0x00		Set bits to 0.
		5:4	LPBK Control			Yes	00: Use LPBK pin control 01: INA_n to OUTB_n loopback 10: INB_n to OUTA_n loopback 11: Disable loopback and ignore LPBK pin.
		3:1	Reserved				Set bits to 0.
		0	Override PWDN pin			Yes	1: Block PWDN pin control 0: Allow PWDN pin control
0x03	Reserved	7:0	Reserved	R/W	0x00		Set bits to 0
0x04	Reserved	7:0	Reserved	R/W	0x00	Yes	Set bits to 0
0x05	Reserved	7:0	Reserved	R/W	0x00		Set bits to 0
0x05	Reserved	7:0	Reserved	R/W	0x00		Reserved
0x06	Slave Register Control	7:5	Reserved	R/W	0x10		Set bits to 0.
		4	Reserved			Yes	Set bit to 1.
		3	Register Enable				1 = Enable SMBus Register Control 0 = Disable SMBus Register Control Note: In order to change VOD, DEM, and EQ of the channels in slave mode, this bit must be set to 1.
0x07	Digital Reset and Control	7	Reserved	R/W	0x01		Set bit to 0.
		6	Reset Registers				Self clearing bit, set to 1 to reset the register to default values
		5	Reset SMBus Master				Self clearing reset to SMBus master state machine
		4:0	Reserved				Set bits to 0 0001'b.
0x08	Override Pin Control	7	Reserved	R/W	0x00		Set bit to 0.
		6	Override SD_TH			Yes	1: Block SD_TH pin control 0: Allow SD_TH pin control
		5	Reserved			Yes	Set bit to 0.
		4	Override IDLE			Yes	1: IDLE control by registers 0: IDLE control by signal detect
		3	Override RXDET			Yes	1: Block RXDET pin control 0: Allow RXDET pin control
		2	Override MODE			Yes	1: Block MODE pin control 0: Allow MODE pin control
		1	Reserved				Set bit to 0.
		0	Reserved				Set bit to 0.
0x09	Reserved	7:0	Reserved	R/W	0x00		Set bits to 0
0x0A	Signal Detect Monitor	7:0	SD_TH Status	R	0x00		CH7 - CH0 Internal Signal Detector Indicator [7]: CH7 - CHA_3 [6]: CH6 - CHA_2 [5]: CH5 - CHA_1 [4]: CH4 - CHA_0 [3]: CH3 - CHB_3 [2]: CH2 - CHB_2 [1]: CH1 - CHB_1 [0]: CH0 - CHB_0 0 = Signal detected at input (active data) 1 = Signal not detected at input (idle state) NOTE: These bits only function when RATE pin = FLOAT
0x0B	Reserved	7	Reserved	R/W	0x00		Set bits to 0
		6:0	Reserved	R/W	0x70	Yes	Set bits to 111 0000'b

Register Maps (continued)

Table 10. SMBUS Slave Mode Register Map (continued)

Address	Register Name	Bit	Field	Type	Default	EEPROM Bit	Description
0x0C	Reserved	7:0	Reserved	R/W	0x00		Set bits to 0
0x0D	CH0 - CHB0 Signal Detect	7:3	Reserved	R/W	0x00		Set bits to 0.
		2	SD Reset				1: Force signal detect "off" 0: Normal operation
		1	SD Preset				1: Force signal detect "on" 0: Normal operation
		0	Reserved				Set bit to 0.
0x0E	CH0 - CHB0 IDLE, RXDET	7:6	Reserved	R/W	0x00		Set bits to 0.
		5	IDLE_AUTO			Yes	1 = Allow IDLE_SEL control in bit 4 0 = Automatic IDLE detect Note: override IDLE control.
		4	IDLE_SEL			Yes	1: Output is MUTED (electrical idle) 0: Output is ON Note: override IDLE control.
		3:2	RXDET			Yes	00: Input is hi-z impedance 01: Auto RX-Detect, outputs test every 12 ms for 600 ms (50 times) then stops; termination is hi-z until detection; once detected input termination is 50 Ω 10: Auto RX-Detect, outputs test every 12 ms until detection occurs; termination is hi-z until detection; once detected input termination is 50 Ω 11: Input is 50 Ω Note: override RXDET pin.
		1:0	Reserved				Set bits to 0.
0x0F	CH0 - CHB0 EQ	7:0	EQ Control	R/W	0x2F	Yes	IB0 EQ Control - total of 256 levels. See Table 2 .
0x10	CH0 - CHB0 VOD	7	Short Circuit Protection	R/W	0xAD	Yes	1: Enable the short circuit protection 0: Disable the short circuit protection
		6	MODE_SEL			Yes	1: PCIe Gen-1 or PCIe Gen-2 0: PCIe Gen-3 Note: override the MODE pin.
		5:3	Reserved			Yes	Set bits to default value - 101.
		2:0	VOD Control			Yes	OB0 VOD Control 000: 0.7 V 001: 0.8 V 010: 0.9 V 011: 1 V 100: 1.1 V 101: 1.2 V (default) 110: 1.3 V 111: 1.4 V

Register Maps (continued)
Table 10. SMBUS Slave Mode Register Map (continued)

Address s	Register Name	Bit	Field	Type	Default	EEPROM Bit	Description
0x11	CH0 - CHB0 DEM	7	RXDET STATUS	R	0x02		Observation bit for RXDET CH0 - CHB0. 1: RX = detected 0: RX = not detected
		6:5	MODE_DET STATUS	R			Observation bit for MODE_DET CH0 - CHB0. 00: PCIe Gen-1 (2.5G) 01: PCIe Gen-2 (5G) 11: PCIe Gen-3 (8G+) Note: Only functions when MODE Pin = Automatic
		4:3	Reserved	R/W			Set bits to 0.
		2:0	DEM Control	R/W		Yes	OB0 DEM Control 000: 0 dB 001: –1.5 dB 010: –3.5 dB (default) 011: –5 dB 100: –6 dB 101: –8 dB 110: –9 dB 111: –12 dB
0x12	CH0 - CHB0 IDLE Threshold	7:4	Reserved	R/W	0x00		Set bits to 0.
		3:2	IDLE tha			Yes	Assert threshold 00 = 180 mVp-p (default) 01 = 160 mVp-p 10 = 210 mVp-p 11 = 190 mVp-p Note: override the SD_TH pin.
		1:0	IDLE thd			Yes	Deassert threshold 00 = 110 mVp-p (default) 01 = 100 mVp-p 10 = 150 mVp-p 11 = 130 mVp-p Note: override the SD_TH pin.
0x13	Reserved	7:0	Reserved	R/W	0x00		Set bits to 0
0x14	CH1 - CHB1 Signal Detect	7:3	Reserved	R/W	0x00		Set bits to 0.
		2	SD Reset				1: Force signal detect "off" 0: Normal operation
		1	SD Preset				1: Force signal detect "on" 0: Normal operation
		0	Reserved				Set bit to 0.
0x15	CH1 - CHB1 IDLE, RXDET	7:6	Reserved	R/W	0x00		Set bits to 0.
		5	IDLE_AUTO			Yes	1 = Allow IDLE_SEL control in bit 4 0 = Automatic IDLE detect Note: override IDLE control.
		4	IDLE_SEL			Yes	1: Output is MUTED (electrical idle) 0: Output is ON Note: override IDLE control.
		3:2	RXDET			Yes	00: Input is hi-z impedance 01: Auto RX-Detect, outputs test every 12 ms for 600 ms (50 times) then stops; termination is hi-z until detection; once detected input termination is 50 Ω 10: Auto RX-Detect, outputs test every 12 ms until detection occurs; termination is high-z until detection; once detected input termination is 50 Ω 11: Input is 50 Ω Note: override RXDET pin.
		1:0	Reserved				Set bits to 0.

Register Maps (continued)

Table 10. SMBUS Slave Mode Register Map (continued)

Address	Register Name	Bit	Field	Type	Default	EEPROM Bit	Description
0x16	CH1 - CHB1 EQ	7:0	EQ Control	R/W	0x2F	Yes	IB1 EQ Control - total of 256 levels. See Table 2 .
0x17	CH1 - CHB1 VOD	7	Short Circuit Protection	R/W	0xAD	Yes	1: Enable the short circuit protection 0: Disable the short circuit protection
		6	MODE_SEL			Yes	1: PCIe Gen-1 or PCIe Gen-2 0: PCIe Gen-3 Note: override the MODE pin.
		5:3	Reserved			Yes	Set bits to default value - 101.
		2:0	VOD Control			Yes	OB1 VOD Control 000: 0.7 V 001: 0.8 V 010: 0.9 V 011: 1 V 100: 1.1 V 101: 1.2 V (default) 110: 1.3 V 111: 1.4 V
0x18	CH1 - CHB1 DEM	7	RXDET STATUS	R	0x02		Observation bit for RXDET CH1 - CHB1. 1: RX = detected 0: RX = not detected
		6:5	MODE_DET STATUS	R			Observation bit for MODE_DET CH1 - CHB1. 00: PCIe Gen-1 (2.5G) 01: PCIe Gen-2 (5G) 11: PCIe Gen-3 (8G+) Note: Only functions when MODE Pin = Automatic
		4:3	Reserved	R/W			Set bits to 0.
		2:0	DEM Control	R/W		Yes	OB1 DEM Control 000: 0 dB 001: -1.5 dB 010: -3.5 dB (default) 011: -5 dB 100: -6 dB 101: -8 dB 110: -9 dB 111: -12 dB
0x19	CH1 - CHB1 IDLE Threshold	7:4	Reserved	R/W	0x00		Set bits to 0.
		3:2	IDLE tha			Yes	Assert threshold 00 = 180 mVp-p (default) 01 = 160 mVp-p 10 = 210 mVp-p 11 = 190 mVp-p Note: override the SD_TH pin.
		1:0	IDLE thd			Yes	Deassert threshold 00 = 110 mVp-p (default) 01 = 100 mVp-p 10 = 150 mVp-p 11 = 130 mVp-p Note: override the SD_TH pin.
0x1A	Reserved	7:0	Reserved	R/W	0x00		Set bits to 0
0x1B	CH2 - CHB2 Signal Detect	7:3	Reserved	R/W	0x00		Set bits to 0.
		2	SD Reset				1: Force signal detect "off" 0: Normal operation
		1	SD Preset				1: Force signal detect "on" 0: Normal operation
		0	Reserved				Set bit to 0.

Register Maps (continued)
Table 10. SMBUS Slave Mode Register Map (continued)

Address	Register Name	Bit	Field	Type	Default	EEPROM Bit	Description
0x1C	CH2 - CHB2 IDLE, RXDET	7:6	Reserved	R/W	0x00		Set bits to 0.
		5	IDLE_AUTO			Yes	1 = Allow IDLE_SEL control in bit 4 0 = Automatic IDLE detect Note: override IDLE control.
		4	IDLE_SEL			Yes	1: Output is MUTED (electrical idle) 0: Output is ON Note: override IDLE control.
		3:2	RXDET			Yes	00: Input is hi-z impedance 01: Auto RX-Detect, outputs test every 12 ms for 600 ms (50 times) then stops; termination is hi-z until detection; once detected input termination is 50 Ω 10: Auto RX-Detect, outputs test every 12 ms until detection occurs; termination is hi-z until detection; once detected input termination is 50 Ω 11: Input is 50 Ω Note: override RXDET pin.
		1:0	Reserved				Set bits to 0.
0x1D	CH2 - CHB2 EQ	7:0	EQ Control	R/W	0x2F	Yes	IB2 EQ Control - total of 256 levels. See Table 2 .
0x1E	CH2 - CHB2 VOD	7	Short Circuit Protection	R/W	0xAD	Yes	1: Enable the short circuit protection 0: Disable the short circuit protection
		6	MODE_SEL			Yes	1: PCIe Gen-1 or PCIe Gen-2 0: PCIe Gen-3 Note: override the MODE pin.
		5:3	Reserved			Yes	Set bits to default value - 101.
		2:0	VOD Control			Yes	OB2 VOD Control 000: 0.7 V 001: 0.8 V 010: 0.9 V 011: 1 V 100: 1.1 V 101: 1.2 V (default) 110: 1.3 V 111: 1.4 V
0x1F	CH2 - CHB2 DEM	7	RXDET STATUS	R	0x02		Observation bit for RXDET CH2 - CHB2. 1: RX = detected 0: RX = not detected
		6:5	MODE_DET STATUS	R			Observation bit for MODE_DET CH2 - CHB2. 00: PCIe Gen-1 (2.5 G) 01: PCIe Gen-2 (5 G) 11: PCIe Gen-3 (8 G+) Note: Only functions when MODE Pin = Automatic
		4:3	Reserved	R/W			Set bits to 0.
		2:0	DEM Control	R/W		Yes	OB2 DEM Control 000: 0 dB 001: -1.5 dB 010: -3.5 dB (default) 011: -5 dB 100: -6 dB 101: -8 dB 110: -9 dB 111: -12 dB

Register Maps (continued)

Table 10. SMBUS Slave Mode Register Map (continued)

Address	Register Name	Bit	Field	Type	Default	EEPROM Bit	Description
0x20	CH2 - CHB2 IDLE Threshold	7:4	Reserved	R/W	0x00		Set bits to 0.
		3:2	IDLE tha			Yes	Assert threshold 00 = 180 mVp-p (default) 01 = 160 mVp-p 10 = 210 mVp-p 11 = 190 mVp-p Note: override the SD_TH pin.
		1:0	IDLE thd			Yes	Deassert threshold 00 = 110 mVp-p (default) 01 = 100 mVp-p 10 = 150 mVp-p 11 = 130 mVp-p Note: override the SD_TH pin.
0x21	Reserved	7:0	Reserved	R/W	0x00		Set bits to 0
0x22	CH3 - CHB3 Signal Detect	7:3	Reserved	R/W	0x00		Set bits to 0.
		2	SD Reset				1: Force signal detect "off" 0: Normal operation
		1	SD Preset				1: Force signal detect "on" 0: Normal operation
		0	Reserved				Set bit to 0.
0x23	CH3 - CHB3 IDLE, RXDET	7:6	Reserved	R/W	0x00		Set bits to 0.
		5	IDLE_AUTO			Yes	1 = Allow IDLE_SEL control in bit 4 0 = Automatic IDLE detect Note: override IDLE control.
		4	IDLE_SEL			Yes	1: Output is MUTED (electrical idle) 0: Output is ON Note: override IDLE control.
		3:2	RXDET			Yes	00: Input is hi-z impedance 01: Auto RX-Detect, outputs test every 12 ms for 600 ms (50 times) then stops; termination is hi-z until detection; once detected input termination is 50 Ω 10: Auto RX-Detect, outputs test every 12 ms until detection occurs; termination is hi-z until detection; once detected input termination is 50 Ω 11: Input is 50 Ω Note: override RXDET pin.
		1:0	Reserved				Set bits to 0.
0x24	CH3 - CHB3 EQ	7:0	EQ Control	R/W	0x2F	Yes	IB3 EQ Control - total of 256 levels. See Table 2 .
0x25	CH3 - CHB3 VOD	7	Short Circuit Protection	R/W	0xAD	Yes	1: Enable the short circuit protection 0: Disable the short circuit protection
		6	MODE_SEL			Yes	1: PCIe Gen-1 or PCIe Gen-2 0: PCIe Gen-3 Note: override the MODE pin.
		5:3	Reserved			Yes	Set bits to default value - 101.
		2:0	VOD Control			Yes	OB0 VOD Control 000: 0.7 V 001: 0.8 V 010: 0.9 V 011: 1 V 100: 1.1 V 101: 1.2 V (default) 110: 1.3 V 111: 1.4 V

Register Maps (continued)
Table 10. SMBUS Slave Mode Register Map (continued)

Address	Register Name	Bit	Field	Type	Default	EEPROM Bit	Description
0x26	CH3 - CHB3 DEM	7	RXDET STATUS	R	0x02		Observation bit for RXDET CH3 - CHB3. 1: RX = detected 0: RX = not detected
		6:5	MODE_DET STATUS	R			Observation bit for MODE_DET CH3 - CHB3. 00: PCIe Gen-1 (2.5G) 01: PCIe Gen-2 (5G) 11: PCIe Gen-3 (8G+) Note: Only functions when MODE Pin = Automatic
		4:3	Reserved	R/W			Set bits to 0.
		2:0	DEM Control	R/W		Yes	OB3 DEM Control 000: 0 dB 001: -1.5 dB 010: -3.5 dB (default) 011: -5 dB 100: -6 dB 101: -8 dB 110: -9 dB 111: -12 dB
0x27	CH3 - CHB3 IDLE Threshold	7:4	Reserved	R/W	0x00		Set bits to 0.
		3:2	IDLE tha			Yes	Assert threshold 00 = 180 mVp-p (default) 01 = 160 mVp-p 10 = 210 mVp-p 11 = 190 mVp-p Note: override the SD_TH pin.
		1:0	IDLE thd			Yes	Deassert threshold 00 = 110 mVp-p (default) 01 = 100 mVp-p 10 = 150 mVp-p 11 = 130 mVp-p Note: override the SD_TH pin.
0x28	Signal Detect Control	7:6	Reserved	R/W	0x0C		Set bits to 0.
		5:4	High IDLE			Yes	Enable higher range of Signal Detect Thresholds [5]: CH0 - CH3 [4]: CH4 -CH7
		3:2	Fast IDLE			Yes	Enable Fast OOB response [3]: CH0 - CH3 [2]: CH4 -CH7
		1:0	Reduced SD Gain			Yes	Enable reduced Signal Detect Gain [1]: CH0 - CH3 [0]: CH4 -CH7
0x29	Reserved	7:0	Reserved	R/W	0x00		Set bits to 0
0x2A	CH4 - CHA0 Signal Detect	7:3	Reserved	R/W	0x00		Set bits to 0.
		2	SD Reset				1: Force signal detect "off" 0: Normal operation
		1	SD Preset				1: Force signal detect "on" 0: Normal operation
		0	Reserved				Set bit to 0.

Register Maps (continued)

Table 10. SMBUS Slave Mode Register Map (continued)

Address s	Register Name	Bit	Field	Type	Default	EEPROM Bit	Description
0x2B	CH4 - CHA0 IDLE, RXDET	7:6	Reserved	R/W	0x00		Set bits to 0.
		5	IDLE_AUTO			Yes	1 = Allow IDLE_SEL control in bit 4 0 = Automatic IDLE detect Note: override IDLE control.
		4	IDLE_SEL			Yes	1: Output is MUTED (electrical idle) 0: Output is ON Note: override IDLE control.
		3:2	RXDET			Yes	00: Input is hi-z impedance 01: Auto RX-Detect, outputs test every 12 ms for 600 ms (50 times) then stops; termination is hi-z until detection; once detected input termination is 50 Ω 10: Auto RX-Detect, outputs test every 12 ms until detection occurs; termination is hi-z until detection; once detected input termination is 50 Ω 11: Input is 50 Ω Note: override RXDET pin.
		1:0	Reserved				Set bits to 0.
0x2C	CH4 - CHA0 EQ	7:0	EQ Control	R/W	0x2F	Yes	IA0 EQ Control - total of 256 levels. See Table 2 .
0x2D	CH4 - CHA0 VOD	7	Short Circuit Protection	R/W	0xAD	Yes	1: Enable the short circuit protection 0: Disable the short circuit protection
		6	MODE_SEL			Yes	1: PCIe Gen-1 or PCIe Gen-2 0: PCIe Gen-3 Note: override the MODE pin.
		5:3	Reserved			Yes	Set bits to default value - 101.
		2:0	VOD Control			Yes	OA0 VOD Control 000: 0.7 V 001: 0.8 V 010: 0.9 V 011: 1 V 100: 1.1 V 101: 1.2 V (default) 110: 1.3 V 111: 1.4 V
0x2E	CH4 - CHA0 DEM	7	RXDET STATUS	R	0x02		Observation bit for RXDET CH4 - CHA0. 1: RX = detected 0: RX = not detected
		6:5	MODE_DET STATUS	R			Observation bit for MODE_DET CH4 - CHA0. 00: PCIe Gen-1 (2.5G) 01: PCIe Gen-2 (5G) 11: PCIe Gen-3 (8G+) Note: Only functions when MODE Pin = Automatic
		4:3	Reserved	R/W			Set bits to 0.
		2:0	DEM Control	R/W		Yes	OA0 DEM Control 000: 0 dB 001: -1.5 dB 010: -3.5 dB (default) 011: -5 dB 100: -6 dB 101: -8 dB 110: -9 dB 111: -12 dB

Register Maps (continued)
Table 10. SMBUS Slave Mode Register Map (continued)

Address s	Register Name	Bit	Field	Type	Default	EEPROM Bit	Description
0x2F	CH4 - CHA0 IDLE Threshold	7:4	Reserved	R/W	0x00		Set bits to 0.
		3:2	IDLE tha			Yes	Assert threshold 00 = 180 mVp-p (default) 01 = 160 mVp-p 10 = 210 mVp-p 11 = 190 mVp-p Note: override the SD_TH pin.
		1:0	IDLE thd			Yes	Deassert threshold 00 = 110 mVp-p (default) 01 = 100 mVp-p 10 = 150 mVp-p 11 = 130 mVp-p Note: override the SD_TH pin.
0x30	Reserved	7:0	Reserved	R/W	0x00		Set bits to 0
0x31	CH5 - CHA1 Signal Detect	7:3	Reserved	R/W	0x00		Set bits to 0.
		2	SD Reset				1: Force signal detect "off" 0: Normal operation
		1	SD Preset				1: Force signal detect "on" 0: Normal operation
		0	Reserved				Set bit to 0.
0x32	CH5 - CHA1 IDLE, RXDET	7:6	Reserved	R/W	0x00		Set bits to 0.
		5	IDLE_AUTO			Yes	1 = Allow IDLE_SEL control in bit 4 0 = Automatic IDLE detect Note: override IDLE control.
		4	IDLE_SEL			Yes	1: Output is MUTED (electrical idle) 0: Output is ON Note: override IDLE control.
		3:2	RXDET			Yes	00: Input is hi-z impedance 01: Auto RX-Detect, outputs test every 12 ms for 600 ms (50 times) then stops; termination is hi-z until detection; once detected input termination is 50 Ω 10: Auto RX-Detect, outputs test every 12 ms until detection occurs; termination is hi-z until detection; once detected input termination is 50 Ω 11: Input is 50 Ω Note: override RXDET pin.
		1:0	Reserved				Set bits to 0.
0x33	CH5 - CHA1 EQ	7:0	EQ Control	R/W	0x2F	Yes	IA1 EQ Control - total of 256 levels. See Table 2 .
0x34	CH5 - CHA1 VOD	7	Short Circuit Protection	R/W	0xAD	Yes	1: Enable the short circuit protection 0: Disable the short circuit protection
		6	MODE_SEL			Yes	1: PCIe Gen-1 or PCIe Gen-2 0: PCIe Gen-3 Note: override the MODE pin.
		5:3	Reserved			Yes	Set bits to default value - 101.
		2:0	VOD Control			Yes	OA1 VOD Control 000: 0.7 V 001: 0.8 V 010: 0.9 V 011: 1 V 100: 1.1 V 101: 1.2 V (default) 110: 1.3 V 111: 1.4 V

Register Maps (continued)

Table 10. SMBUS Slave Mode Register Map (continued)

Address	Register Name	Bit	Field	Type	Default	EEPROM Bit	Description
0x35	CH5 - CHA1 DEM	7	RXDET STATUS	R	0x02		Observation bit for RXDET CH5 - CHA1. 1: RX = detected 0: RX = not detected
		6:5	MODE_DET STATUS	R			Observation bit for MODE_DET CH5 - CHA1. 00: PCIe Gen-1 (2.5G) 01: PCIe Gen-2 (5G) 11: PCIe Gen-3 (8G+) Note: Only functions when MODE Pin = Automatic
		4:3	Reserved	R/W			Set bits to 0.
		2:0	DEM Control	R/W		Yes	OA1 DEM Control 000: 0 dB 001: -1.5 dB 010: -3.5 dB (default) 011: -5 dB 100: -6 dB 101: -8 dB 110: -9 dB 111: -12 dB
0x36	CH5 - CHA1 IDLE Threshold	7:4	Reserved	R/W	0x00		Set bits to 0.
		3:2	IDLE tha			Yes	Assert threshold 00 = 180 mVp-p (default) 01 = 160 mVp-p 10 = 210 mVp-p 11 = 190 mVp-p Note: override the SD_TH pin.
		1:0	IDLE thd			Yes	Deassert threshold 00 = 110 mVp-p (default) 01 = 100 mVp-p 10 = 150 mVp-p 11 = 130 mVp-p Note: override the SD_TH pin.
0x37	Reserved	7:0	Reserved	R/W	0x00		Set bits to 0
0x38	CH6 - CHA2 Signal Detect	7:3	Reserved	R/W	0x00		Set bits to 0.
		2	SD Reset				1: Force signal detect "off" 0: Normal operation
		1	SD Preset				1: Force signal detect "on" 0: Normal operation
		0	Reserved				Set bit to 0.
0x39	CH6 - CHA2 IDLE, RXDET	7:6	Reserved	R/W	0x00		Set bits to 0.
		5	IDLE_AUTO			Yes	1 = Allow IDLE_SEL control in bit 4 0 = Automatic IDLE detect Note: override IDLE control.
		4	IDLE_SEL			Yes	1: Output is MUTED (electrical idle) 0: Output is ON Note: override IDLE control.
		3:2	RXDET			Yes	00: Input is hi-z impedance 01: Auto RX-Detect, outputs test every 12 ms for 600 ms (50 times) then stops; termination is hi-z until detection; once detected input termination is 50 Ω 10: Auto RX-Detect, outputs test every 12 ms until detection occurs; termination is hi-z until detection; once detected input termination is 50 Ω 11: Input is 50 Ω Note: override RXDET pin.
		1:0	Reserved				Set bits to 0.

Register Maps (continued)
Table 10. SMBUS Slave Mode Register Map (continued)

Address	Register Name	Bit	Field	Type	Default	EEPROM Bit	Description
0x3A	CH6 - CHA2 EQ	7:0	EQ Control	R/W	0x2F	Yes	IA2 EQ Control - total of 256 levels. See Table 2 .
0x3B	CH6 - CHA2 VOD	7	Short Circuit Protection	R/W	0xAD	Yes	1: Enable the short circuit protection 0: Disable the short circuit protection
		6	MODE_SEL			Yes	1: PCIe Gen-1 or PCIe Gen-2 0: PCIe Gen-3 Note: override the MODE pin.
		5:3	Reserved			Yes	Set bits to default value - 101.
		2:0	VOD Control			Yes	OA2 VOD Control 000: 0.7 V 001: 0.8 V 010: 0.9 V 011: 1 V 100: 1.1 V 101: 1.2 V (default) 110: 1.3 V 111: 1.4 V
0x3C	CH6 - CHA2 DEM	7	RXDET STATUS	R	0x02		Observation bit for RXDET CH6 - CHA2. 1: RX = detected 0: RX = not detected
		6:5	MODE_DET STATUS	R			Observation bit for MODE_DET CH6 - CHA2. 00: PCIe Gen-1 (2.5G) 01: PCIe Gen-2 (5G) 11: PCIe Gen-3 (8G+) Note: Only functions when MODE Pin = Automatic
		4:3	Reserved	R/W			Set bits to 0.
		2:0	DEM Control	R/W		Yes	OA2 DEM Control 000: 0 dB 001: -1.5 dB 010: -3.5 dB (default) 011: -5 dB 100: -6 dB 101: -8 dB 110: -9 dB 111: -12 dB
0x3D	CH6 - CHA2 IDLE Threshold	7:4	Reserved	R/W	0x00		Set bits to 0.
		3:2	IDLE tha			Yes	Assert threshold 00 = 180 mVp-p (default) 01 = 160 mVp-p 10 = 210 mVp-p 11 = 190 mVp-p Note: override the SD_TH pin.
		1:0	IDLE thd			Yes	Deassert threshold 00 = 110 mVp-p (default) 01 = 100 mVp-p 10 = 150 mVp-p 11 = 130 mVp-p Note: override the SD_TH pin.
0x3E	Reserved	7:0	Reserved	R/W	0x00		Set bits to 0
0x3F	CH7 - CHA3 Signal Detect	7:3	Reserved	R/W	0x00		Set bits to 0.
		2	SD Reset				1: Force signal detect "off" 0: Normal operation
		1	SD Preset				1: Force signal detect "on" 0: Normal operation
		0	Reserved				Set bit to 0.

Register Maps (continued)

Table 10. SMBUS Slave Mode Register Map (continued)

Address	Register Name	Bit	Field	Type	Default	EEPROM Bit	Description
0x40	CH7 - CHA3 IDLE, RXDET	7:6	Reserved	R/W	0x00		Set bits to 0.
		5	IDLE_AUTO			Yes	1 = Allow IDLE_SEL control in bit 4 0 = Automatic IDLE detect Note: override IDLE control.
		4	IDLE_SEL			Yes	1: Output is MUTED (electrical idle) 0: Output is ON Note: override IDLE control.
		3:2	RXDET			Yes	00: Input is hi-z impedance 01: Auto RX-Detect, outputs test every 12 ms for 600 ms (50 times) then stops; termination is hi-z until detection; once detected input termination is 50 Ω 10: Auto RX-Detect, outputs test every 12 ms until detection occurs; termination is hi-z until detection; once detected input termination is 50 Ω 11: Input is 50 Ω Note: override RXDET pin.
		1:0	Reserved				Set bits to 0.
0x41	CH7 - CHA3 EQ	7:0	EQ Control	R/W	0x2F	Yes	IA3 EQ Control - total of 256 levels. See Table 2 .
0x42	CH7 - CHA3 VOD	7	Short Circuit Protection	R/W	0xAD	Yes	1: Enable the short circuit protection 0: Disable the short circuit protection
		6	MODE_SEL			Yes	1: PCIe Gen-1 or PCIe Gen-2 0: PCIe Gen-3 Note: override the MODE pin.
		5:3	Reserved			Yes	Set bits to default value - 101.
		2:0	VOD Control			Yes	OA3 VOD Control 000: 0.7 V 001: 0.8 V 010: 0.9 V 011: 1 V 100: 1.1 V 101: 1.2 V (default) 110: 1.3 V 111: 1.4 V
0x43	CH7 - CHA3 DEM	7	RXDET STATUS	R	0x02		Observation bit for RXDET CH7 - CHA3. 1: RX = detected 0: RX = not detected
		6:5	MODE_DET STATUS	R			Observation bit for MODE_DET CH7 - CHA3. 00: PCIe Gen-1 (2.5G) 01: PCIe Gen-2 (5G) 11: PCIe Gen-3 (8G+) Note: Only functions when MODE Pin = Automatic
		4:3	Reserved	R/W			Set bits to 0.
		2:0	DEM Control	R/W		Yes	OA3 DEM Control 000: 0 dB 001: -1.5 dB 010: -3.5 dB (default) 011: -5 dB 100: -6 dB 101: -8 dB 110: -9 dB 111: -12 dB

Register Maps (continued)
Table 10. SMBUS Slave Mode Register Map (continued)

Address	Register Name	Bit	Field	Type	Default	EEPROM Bit	Description
0x44	CH7 - CHA3 IDLE Threshold	7:4	Reserved	R/W	0x00		Set bits to 0.
		3:2	IDLE tha			Yes	Assert threshold 00 = 180 mVp-p (default) 01 = 160 mVp-p 10 = 210 mVp-p 11 = 190 mVp-p Note: override the SD_TH pin.
		1:0	IDLE thd			Yes	Deassert threshold 00 = 110 mVp-p (default) 01 = 100 mVp-p 10 = 150 mVp-p 11 = 130 mVp-p Note: override the SD_TH pin.
0x45	Reserved	7:0	Reserved	R/W	0x00		Set bits to 0
0x46	Reserved	7:0	Reserved	R/W	0x38		Set bits to 0x38
0x47	Reserved	7:4	Reserved	R/W	0x00		Set bits to 0
		3:0	Reserved	R/W		Yes	Set bits to 0
0x48	Reserved	7:6	Reserved	R/W	0x05	Yes	Set bits to 0
		5:0	Reserved	R/W			Set bits to 00 0101'b
0x49	Reserved	7:0	Reserved	R/W	0x00		Set bits to 0
0x4A	Reserved	7:0	Reserved	R/W	0x00		Set bits to 0
0x4B	Reserved	7:0	Reserved	R/W	0x00		Set bits to 0
0x4C	Reserved	7:3	Reserved	R/W	0x00	Yes	Set bits to 0
		2:1	Reserved	R/W			Set bits to 0
		0	Reserved	R/W		Yes	Set bits to 0
0x4D	Reserved	7:0	Reserved	R/W	0x00		Set bits to 0
0x4E	Reserved	7:0	Reserved	R/W	0x00		Set bits to 0
0x4F	Reserved	7:0	Reserved	R/W	0x00		Set bits to 0
0x50	Reserved	7:0	Reserved	R/W	0x00		Set bits to 0
0x51	Device ID	7:5	VERSION	R	0x44		010'b
		4:0	ID				00100'b
0x52	Reserved	7:0	Reserved	R/W	0x00		Set bits to 0
0x53	Reserved	7:0	Reserved	R/W	0x00		Set bits to 0
0x54	Reserved	7:0	Reserved	R/W	0x00		Set bits to 0
0x55	Reserved	7:0	Reserved	R/W	0x00		Set bits to 0
0x56	Reserved	7:0	Reserved	R/W	0x10		Set bits to 0x10
0x57	Reserved	7:0	Reserved	R/W	0x64		Set bits to 0x64
0x58	Reserved	7:0	Reserved	R/W	0x21		Set bits to 0x21
0x59	Reserved	7:1	Reserved	R/W	0x00		Set bits to 0
		0	Reserved			Yes	Set bit to 0
0x5A	Reserved	7:0	Reserved	R/W	0x54	Yes	Set bits to 0x54
0x5B	Reserved	7:0	Reserved	R/W	0x54	Yes	Set bits to 0x54
0x5C	Reserved	7:0	Reserved	R/W	0x00		Set bits to 0
0x5D	Reserved	7:0	Reserved	R/W	0x00		Set bits to 0
0x5E	Reserved	7:0	Reserved	R/W	0x00		Set bits to 0
0x5F	Reserved	7:0	Reserved	R/W	0x00		Set bits to 0
0x60	Reserved	7:0	Reserved	R/W	0x00		Set bits to 0
0x61	Reserved	7:0	Reserved	R/W	0x00		Set bits to 0

10 Application and Implementation

NOTE

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes. Customers should validate and test their design implementation to confirm system functionality.

10.1 Application Information

The DS125BR401 is a high performance circuit capable of delivering excellent performance. Careful attention must be paid to the details associated with high-speed design as well as providing a clean power supply. Refer to the following information and Revision 4 of the *LVDS Owner's Manual* for more detailed information on high-speed design tips to address signal integrity design issues.

10.2 Typical Application

The DS125BR401 works to extend the reach possible by using active equalization on the channel, boosting attenuated signals so that they can be more easily recovered at the Rx endpoint. The capability of the repeater can be explored across a range of data rates and ASIC-to-link-partner signaling, as shown in the following test setup connections. The test setup connections diagrams shown represent typical generic application scenarios for the DS125BR401.

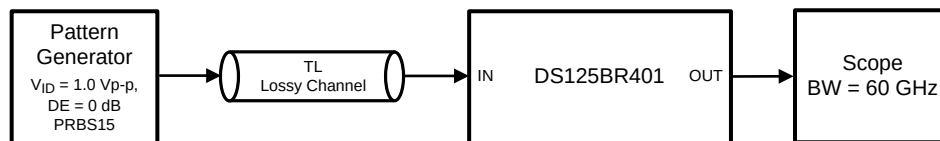


Figure 9. Test Setup Connections Diagram



Figure 10. Test Setup Connections Diagram

10.2.1 Design Requirements

As with any high speed design, there are many factors which influence the overall performance. Below are a list of critical areas for consideration and study during design.

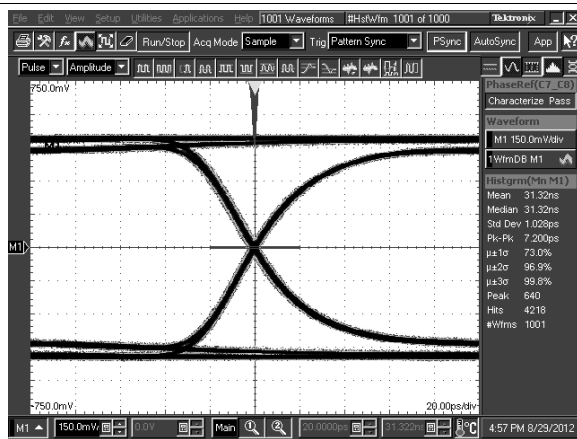
- Use 100-Ω impedance traces. Generally these are very loosely coupled to ease routing length differences.
- Place AC-coupling capacitors near to the receiver end of each channel segment to minimize reflections.
- The maximum body size for AC-coupling capacitors is 0402.
- Back-drill connector vias and signal vias to minimize stub length.
- Use Reference plane vias to ensure a low inductance path for the return current.

10.2.2 Detailed Design Procedure

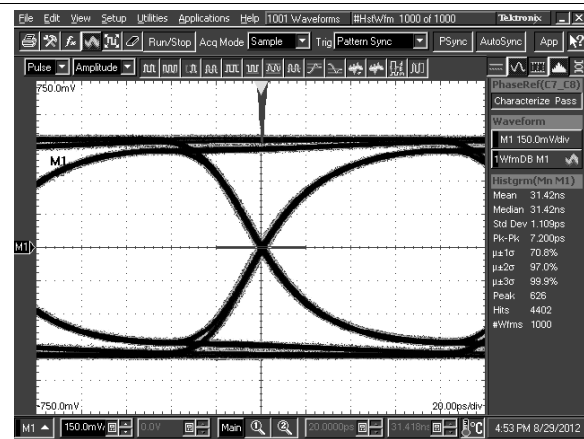
The DS125BR401 is designed to be placed at a location where the input CTLE can help to compensate for a portion of the overall channel attenuation. In order to optimize performance, the repeater requires tuning to extend the reach of the cable or trace length while also recovering a solid eye opening. To tune the repeater, TI recommends the settings mentioned in [Table 2](#) and [Table 3](#) (for Pin Mode) as a default starting point for most applications. Once these settings are configured, additional tuning of the EQ and, to a lesser extent, VOD may be required to optimize the repeater performance for each specific application environment. Examples of the repeater performance as a generic high-speed datapath repeater are illustrated in the performance curves in the next section.

Typical Application (continued)

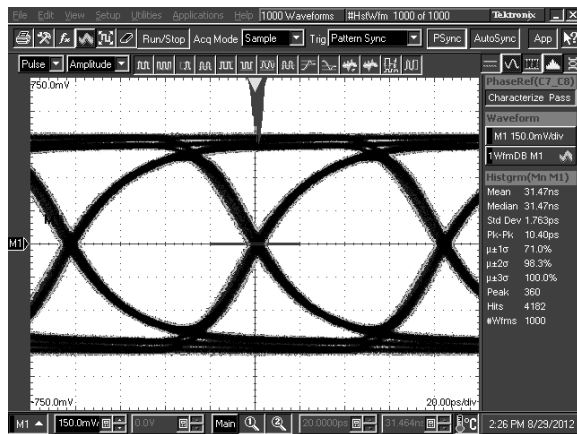
10.2.3 Application Curves



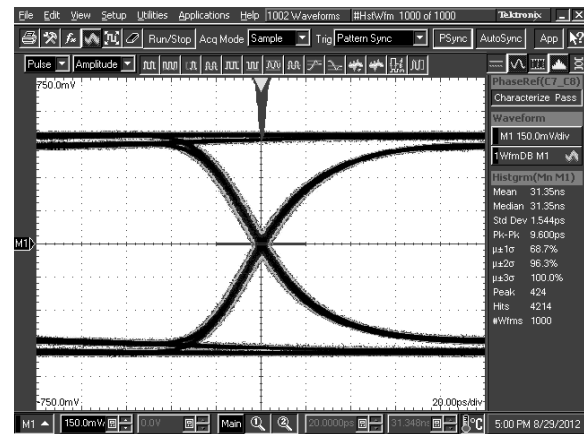
DS125BR401 settings: EQ[1:0] = 0, F = 0x02, DEM[1:0] = 0, 1
Figure 11. TL = 10-Inch 5-Mil FR4 Trace, 5 Gbps



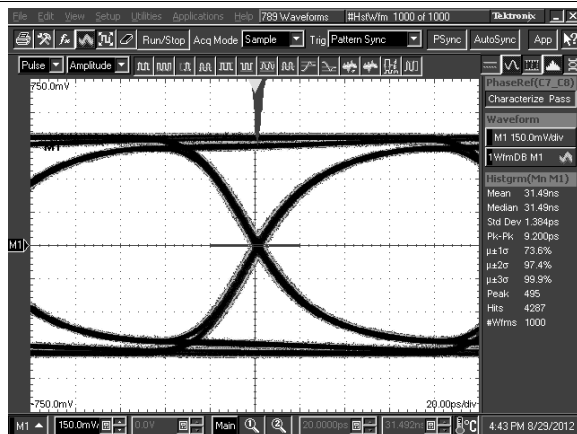
DS125BR401 settings: EQ[1:0] = 0, F = 0x02, DEM[1:0] = 0, 1
Figure 12. TL = 10-Inch 5-Mil FR4 Trace, 8 Gbps



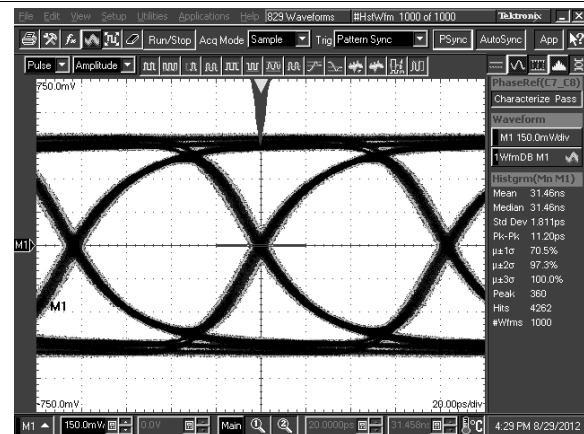
DS125BR401 settings: EQ[1:0] = 0, R = 0x01, DEM[1:0] = 0, 1
Figure 13. TL = 10-Inch 5-Mil FR4 Trace, 12 Gbps



DS125BR401 settings: EQ[1:0] = 0, 1 = 0x03, DEM[1:0] = 0, 1
Figure 14. TL = 20-Inch 5-Mil FR4 Trace, 5 Gbps

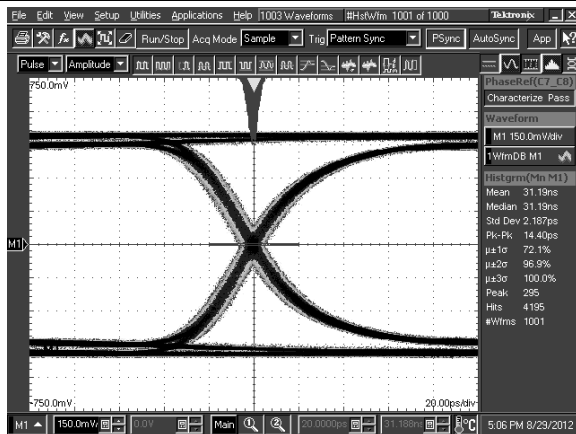


DS125BR401 settings: EQ[1:0] = 0, 1 = 0x03, DEM[1:0] = 0, 1
Figure 15. TL = 20-Inch 5-Mil FR4 Trace, 8 Gbps

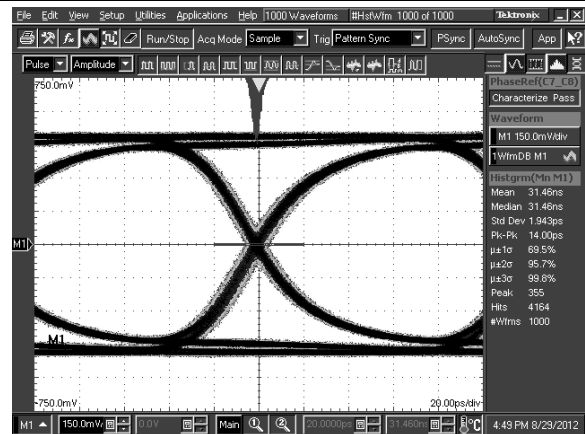


DS125BR401 settings: EQ[1:0] = 0, 1 = 0x03, DEM[1:0] = 0, 1
Figure 16. TL = 20-Inch 5-Mil FR4 Trace, 12 Gbps

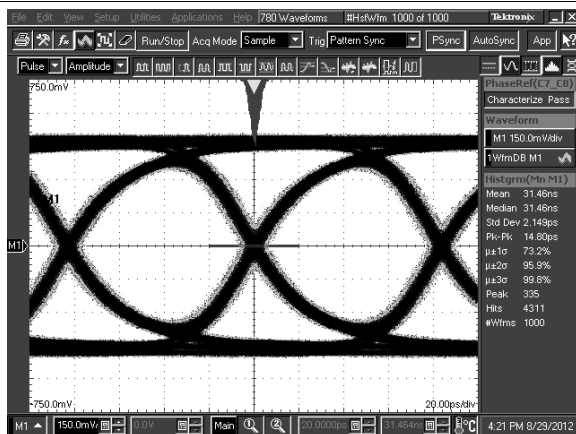
Typical Application (continued)



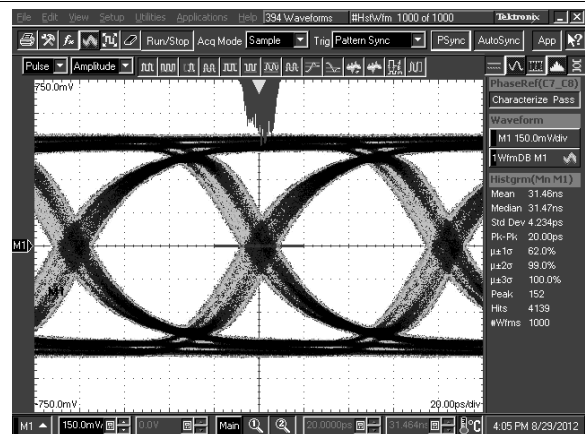
DS125BR401 settings: EQ[1:0] = R, 0 = 0x07, DEM[1:0] = 0, 1
Figure 17. TL = 30-Inch 5-Mil FR4 Trace, 5 Gbps



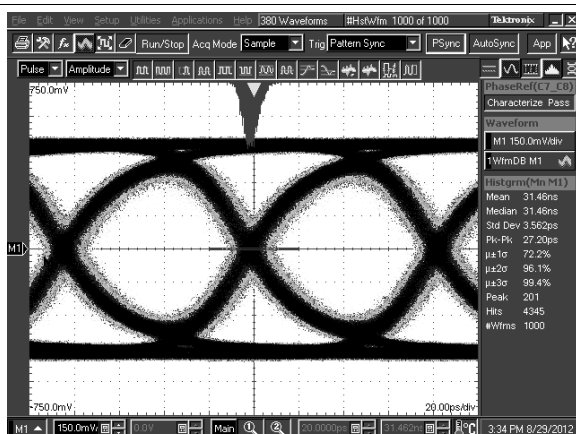
DS125BR401 settings: EQ[1:0] = R, 0 = 0x07, DEM[1:0] = 0, 1
Figure 18. TL = 30-Inch 5-Mil FR4 Trace, 8 Gbps



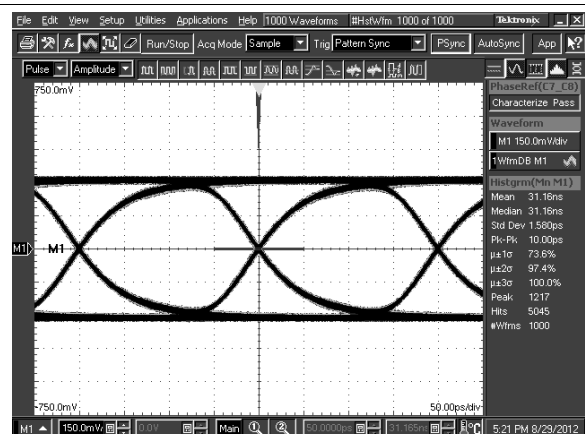
DS125BR401 settings: EQ[1:0] = R, 0 = 0x07, DEM[1:0] = 0, 1
Figure 19. TL = 30-Inch 5-Mil FR4 Trace, 12 Gbps



DS125BR401 settings: EQ[1:0] = R, 0 = 0x07, DEM[1:0] = 0, 1
Figure 20. TL1 = 5-Meter 30-AWG 100-Ω Twin-Axial Cable, 12 Gbps



DS125BR401 settings: EQ[1:0] = R, 1 = 0x0F, DEM[1:0] = 0, 1
Figure 21. TL1 = 8-Meter 30-AWG 100-Ω Twin-Axial Cable, 12 Gbps



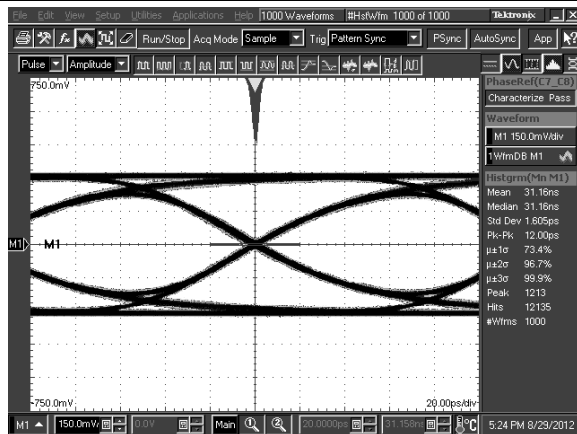
DS125BR401 settings: EQ[1:0] = 0, 1 = 0x03, DEM[1:0] = R, 0
Figure 22. TL1 = 20-Inch 5-Mil FR4 Trace, TL2 = 10-Inch 5-Mil FR4 Trace, 5 Gbps

DS125BR401

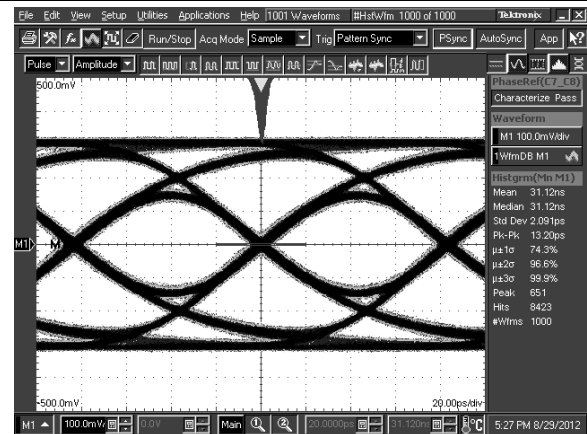
ZHCSDR9D – JULY 2012 – REVISED MAY 2015

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Typical Application (continued)



DS125BR401 settings: EQ[1:0] = R, 1 = 0x0F, DEM[1:0] = R, 0
**Figure 23. TL1 = 20-Inch 5-Mil FR4 Trace,
 TL2 = 10-Inch 5-Mil FR4 Trace, 8 Gbps**



DS125BR401 settings: EQ[1:0] = R, 1 = 0x0F, DEM[1:0] = R, 0
Figure 24. TL1 = 20-Inch 5-Mil FR4 Trace, TL2 = 10-Inch 5-Mil FR4 Trace, 12 Gbps

11 Power Supply Recommendations

11.1 3.3-V or 2.5-V Supply Mode Operation

The DS125BR401 has an optional internal voltage regulator to provide the 2.5-V supply to the device. In 3.3-V mode operation, the VIN pin = 3.3 V is used to supply power to the device. The internal regulator will provide the 2.5 V to the VDD pins of the device and a 0.1 μ F capacitor is needed at each of the 5 VDD pins for power supply decoupling (total capacitance should be ≤ 0.5 μ F), and the VDD_SEL pin must be tied to GND to enable the internal regulator. In 2.5-V mode operation, the VIN pin should be left open and the 2.5-V supply must be applied to the 5 VDD pins to power the device. The VDD_SEL pin must be left open (no connect) to disable the internal regulator.

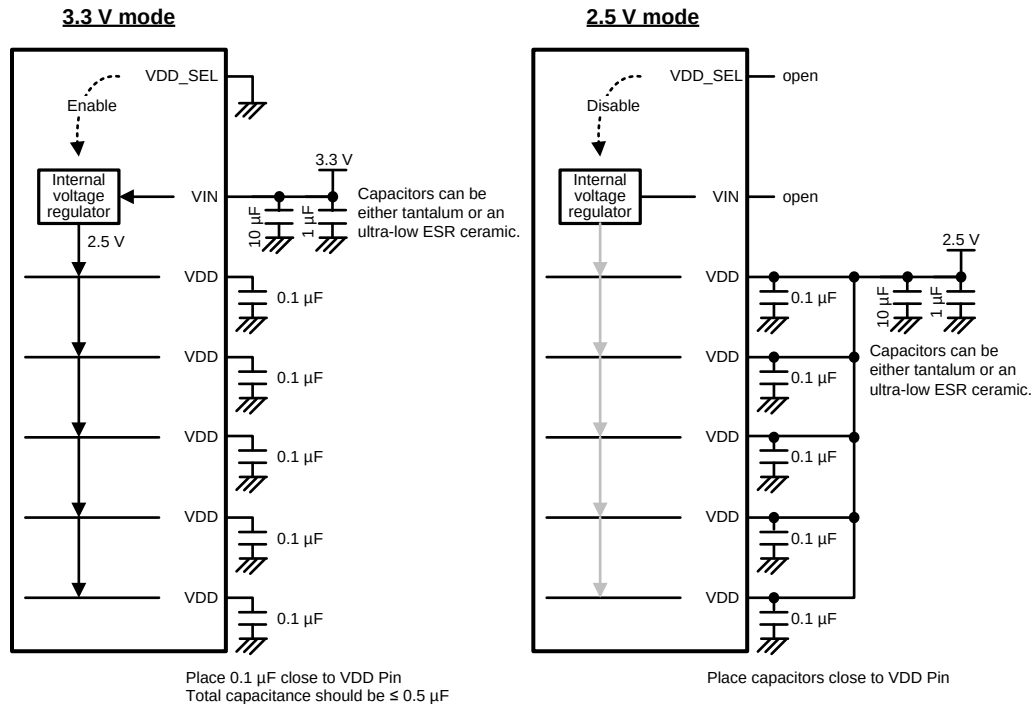


Figure 25. 3.3-V or 2.5-V Supply Connection Diagram

11.2 Power Supply Bypassing

TI recommends two routing options to ensure that the DS125BR401 is provided with an adequate power supply. First, the supply (VDD) and ground (GND) pins should be connected to power planes routed on adjacent layers of the printed circuit board. The layer thickness of the dielectric should be minimized so that the V_{DD} and GND planes create a low inductance supply with distributed capacitance. Second, careful attention to supply bypassing through the proper use of bypass capacitors is required. A 0.1- μ F bypass capacitor should be connected to each V_{DD} pin such that the capacitor is placed as close as possible to the DS125BR401. Smaller body size capacitors can help facilitate proper component placement. Additionally, capacitor with capacitance in the range of 1 μ F to 10 μ F should be incorporated in the power supply bypassing design as well. These capacitors can be either tantalum or an ultra-low ESR ceramic.

12 Layout

12.1 Layout Guidelines

12.1.1 PCB Layout Considerations for Differential Pairs

The CML inputs and LPDS outputs have been optimized to work with interconnects using a controlled differential impedance of $85\ \Omega$ to $100\ \Omega$. It is preferable to route differential lines exclusively on one layer of the board, particularly for the input traces. The use of vias should be avoided if possible. If vias must be used, they should be used sparingly and must be placed symmetrically for each side of a given differential pair. Whenever differential vias are used the layout must also provide for a low inductance path for the return currents as well. Route the differential signals away from other signals and noise sources on the printed circuit board. See AN-1187 *Leadless Leadframe Package (LLP) Application Report (SNOA401)* for additional information on QFN (WQFN) packages.

Figure 26 depicts different transmission line topologies which can be used in various combinations to achieve the optimal system performance. Impedance discontinuities at the differential via can be minimized or eliminated by increasing the swell around each hole and providing for a low inductance return current path. When the via structure is associated with thick backplane PCB, further optimization such as back drilling is often used to reduce the detrimental high frequency effects of stubs on the signal path.

12.2 Layout Example

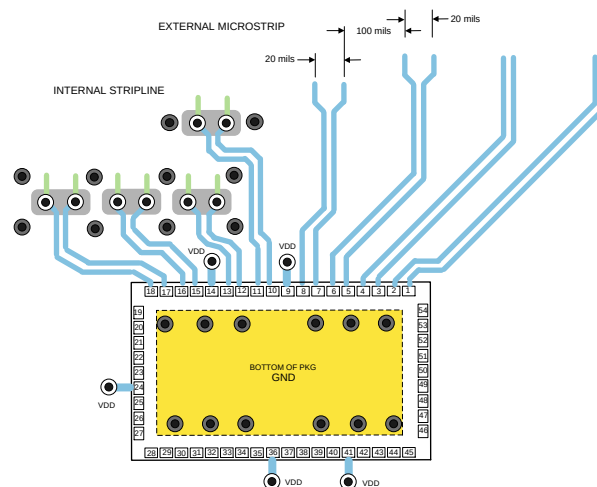


Figure 26. Typical Routing Options

13 器件和文档支持

13.1 文档支持

13.1.1 相关文档

- 《无引线框架封装 (LLP) 应用报告》（文献编号：[SNOA401](#)）
- 《焊接相关的最大绝对额定值》（文献编号：[SNOA549](#)）

13.2 Community Resources

下列链接提供到 TI 社区资源的连接。链接的内容由各个分销商“按照原样”提供。这些内容并不构成 TI 技术规范 and 标准且不一定反映 TI 的观点；请见 TI 的[使用条款](#)。

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Design Support **TI's Design Support** Quickly find helpful E2E forums along with design support tools and contact information for technical support.

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13.4 静电放电警告



这些装置包含有限的内置 ESD 保护。存储或装卸时，应将导线一起截短或将装置放置于导电泡棉中，以防止 MOS 门极遭受静电损伤。

13.5 术语表

SLYZ022 — TI 术语表。

这份术语表列出并解释术语、首字母缩略词和定义。

14 机械、封装和可订购信息

以下页中包括机械、封装和可订购信息。 这些信息是针对指定器件可提供的最新数据。 这些数据会在无通知且不
对本文档进行修订的情况下发生改变。 欲获得该数据表的浏览器版本，请查阅左侧的导航栏。

PACKAGING INFORMATION

Orderable part number	Status (1)	Material type (2)	Package Pins	Package qty Carrier	RoHS (3)	Lead finish/ Ball material (4)	MSL rating/ Peak reflow (5)	Op temp (°C)	Part marking (6)
DS125BR401SQ/NOPB	Active	Production	WQFN (NJY) 54	2000 LARGE T&R	Yes	SN	Level-2-260C-1 YEAR	-40 to 85	DS125BR401SQ
DS125BR401SQ/NOPB.A	Active	Production	WQFN (NJY) 54	2000 LARGE T&R	Yes	SN	Level-2-260C-1 YEAR	-40 to 85	DS125BR401SQ
DS125BR401SQ/NOPB.B	Active	Production	WQFN (NJY) 54	2000 LARGE T&R	Yes	SN	Level-2-260C-1 YEAR	-40 to 85	DS125BR401SQ
DS125BR401SQE/NOPB	Active	Production	WQFN (NJY) 54	250 SMALL T&R	Yes	SN	Level-2-260C-1 YEAR	-40 to 85	DS125BR401SQ
DS125BR401SQE/NOPB.A	Active	Production	WQFN (NJY) 54	250 SMALL T&R	Yes	SN	Level-2-260C-1 YEAR	-40 to 85	DS125BR401SQ
DS125BR401SQE/NOPB.B	Active	Production	WQFN (NJY) 54	250 SMALL T&R	Yes	SN	Level-2-260C-1 YEAR	-40 to 85	DS125BR401SQ

⁽¹⁾ **Status:** For more details on status, see our [product life cycle](#).

⁽²⁾ **Material type:** When designated, preproduction parts are prototypes/experimental devices, and are not yet approved or released for full production. Testing and final process, including without limitation quality assurance, reliability performance testing, and/or process qualification, may not yet be complete, and this item is subject to further changes or possible discontinuation. If available for ordering, purchases will be subject to an additional waiver at checkout, and are intended for early internal evaluation purposes only. These items are sold without warranties of any kind.

⁽³⁾ **RoHS values:** Yes, No, RoHS Exempt. See the [TI RoHS Statement](#) for additional information and value definition.

⁽⁴⁾ **Lead finish/Ball material:** Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

⁽⁵⁾ **MSL rating/Peak reflow:** The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.

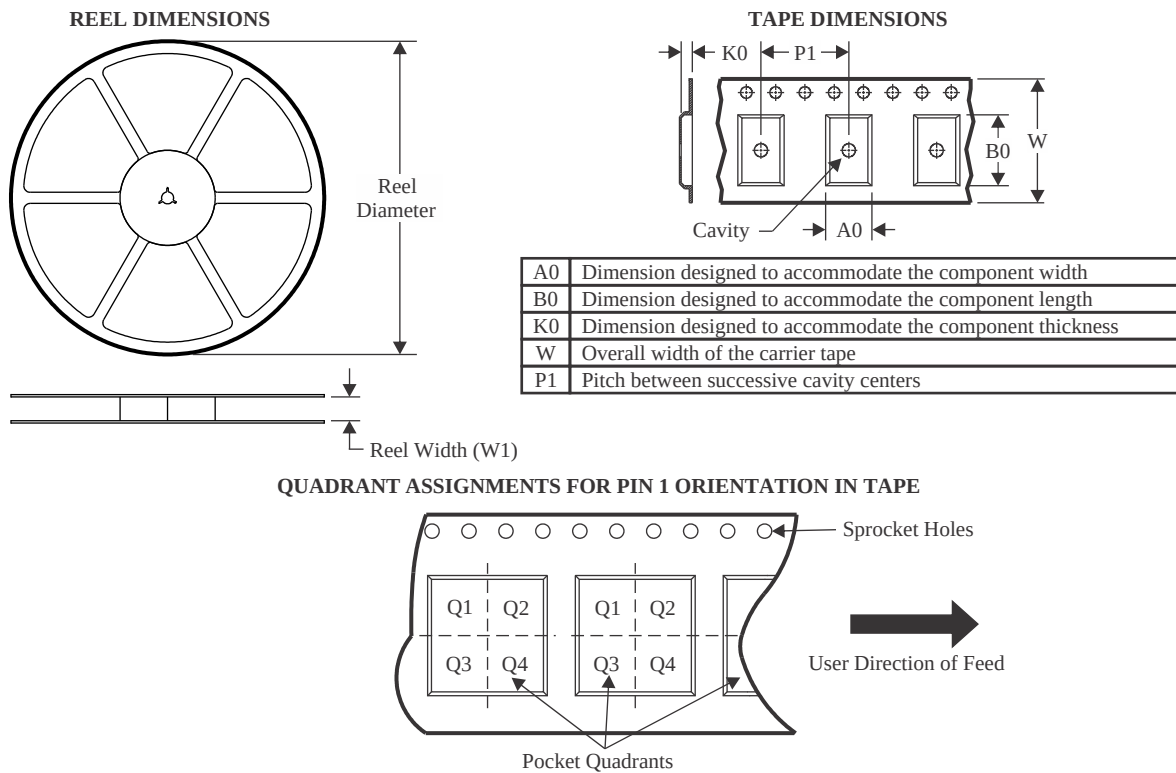
⁽⁶⁾ **Part marking:** There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.

Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "~" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

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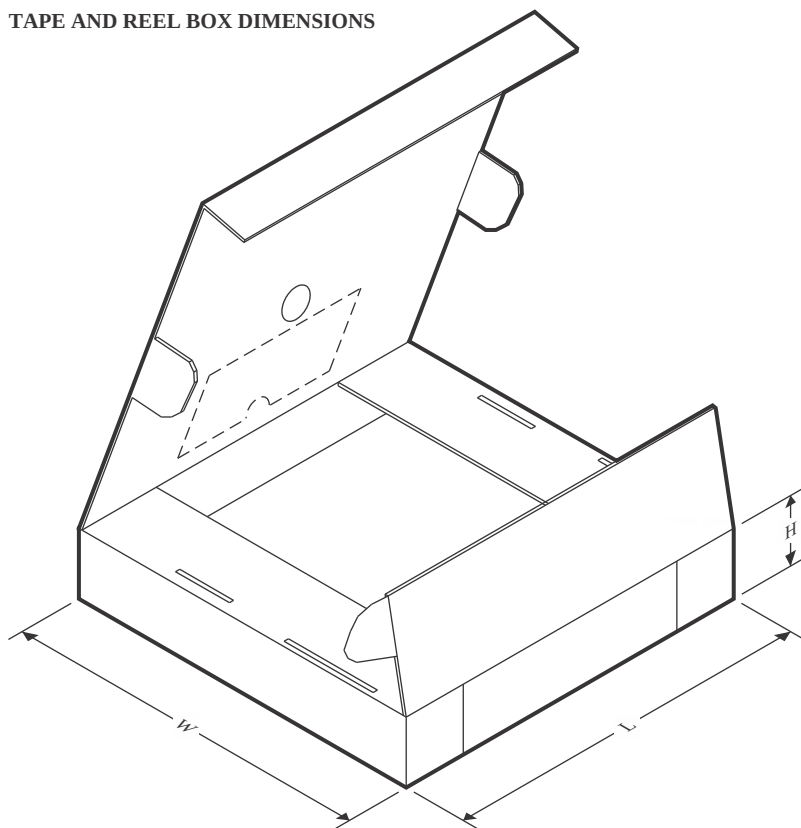
TAPE AND REEL INFORMATION



*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
DS125BR401SQ/NOPB	WQFN	NJY	54	2000	330.0	16.4	5.8	10.3	1.0	12.0	16.0	Q1
DS125BR401SQE/NOPB	WQFN	NJY	54	250	178.0	16.4	5.8	10.3	1.0	12.0	16.0	Q1

TAPE AND REEL BOX DIMENSIONS



*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
DS125BR401SQ/NOPB	WQFN	NJY	54	2000	356.0	356.0	36.0
DS125BR401SQE/NOPB	WQFN	NJY	54	250	208.0	191.0	35.0

WQFN

PIN 1 INDEX AREA

B 5.6
5.4

A

10.1
9.9

C

SEATING PLANE

0.8 MAX

SEE TERMINAL DETAIL

19 27 28

18

7.5±0.1

2X 4

3.51±0.1

50X 0.5

2X 8.5

1

54

46

45

54X 0.3
0.2

54X 0.5
0.3

PIN 1 ID (OPTIONAL)

⊕	0.1M	C	A	S	B	S
	0.05M	C				

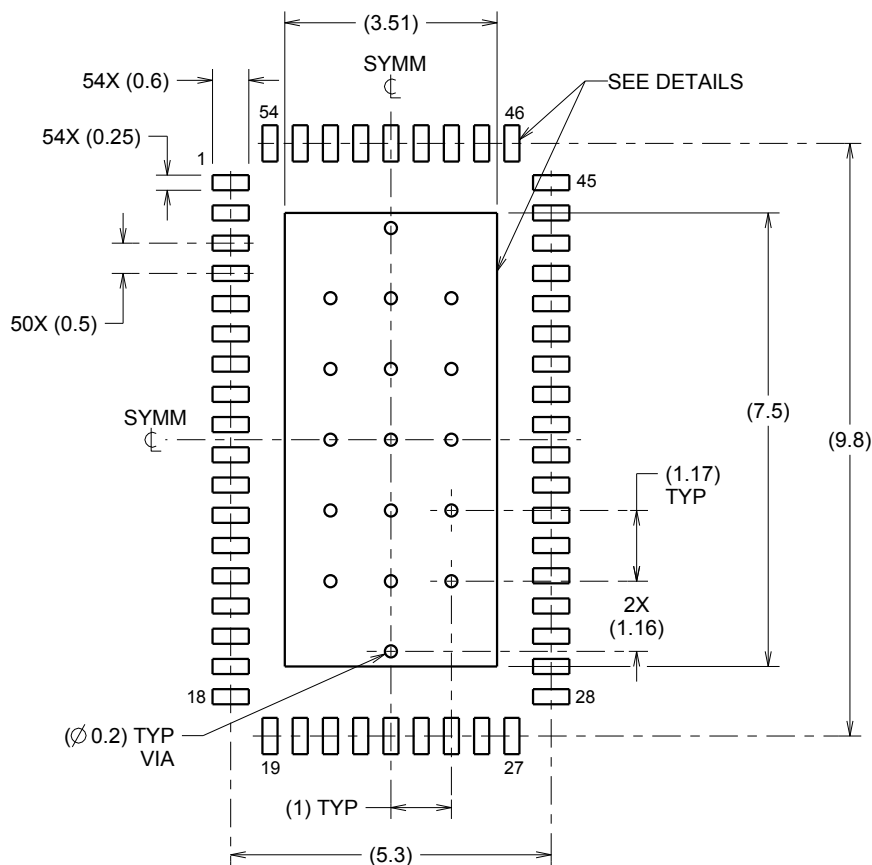
(0.1)

DETAIL
OPTIONAL TERMINAL
TYPICAL

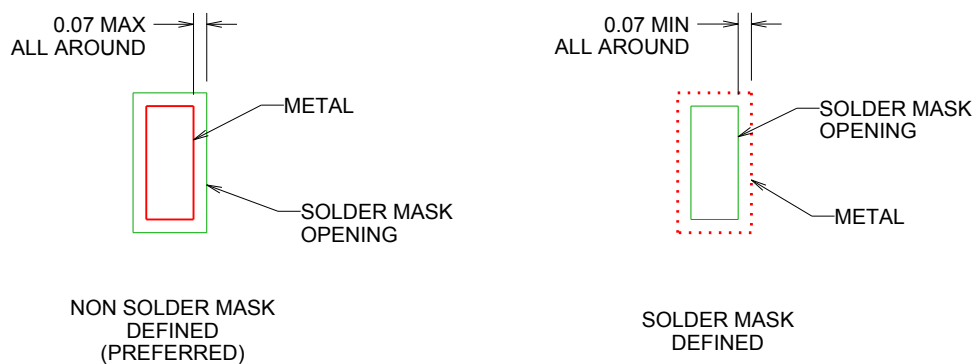
0.3
0.2

0.5
0.3

1. All linear dimensions are in millimeters. Dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. The package thermal pad must be soldered to the printed circuit board for thermal and mechanical performance.



LAND PATTERN EXAMPLE
SCALE:8X

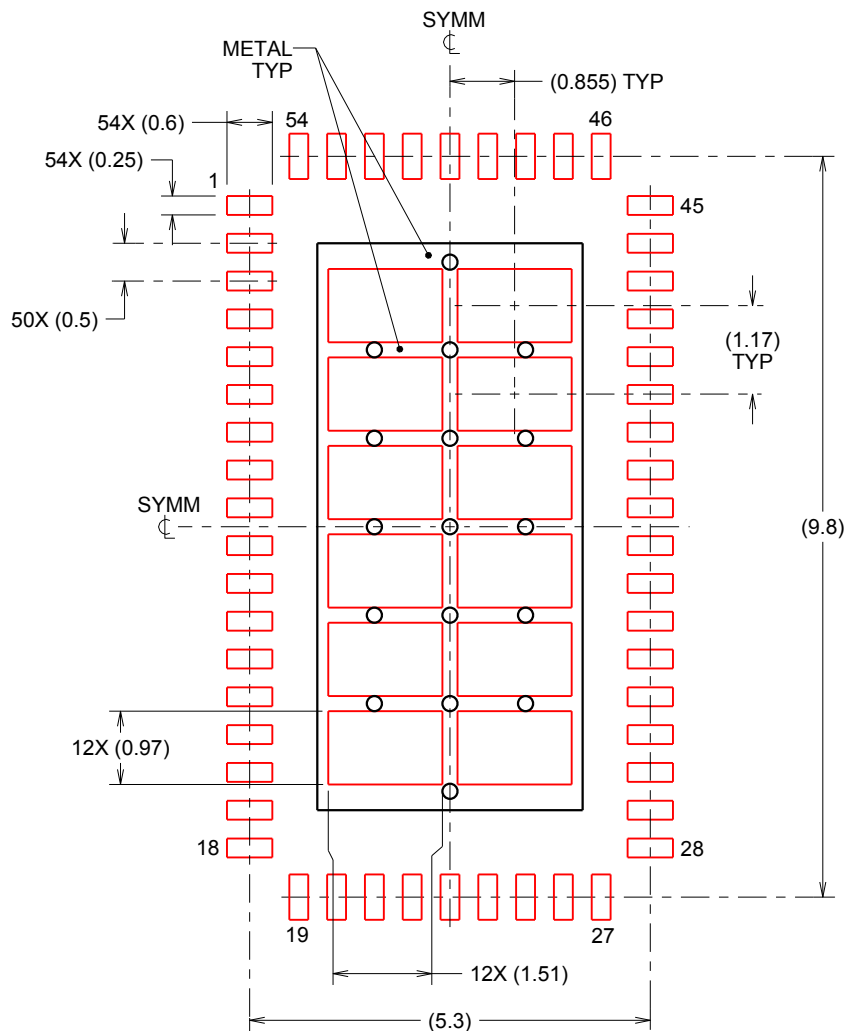


SOLDER MASK DETAILS

4214993/A 07/2013

NOTES: (continued)

4. This package is designed to be soldered to a thermal pad on the board. For more information, refer to QFN/SON PCB application note in literature No. SLUA271 (www.ti.com/lit/slua271).



SOLDERPASTE EXAMPLE BASED ON 0.125mm THICK STENCIL

EXPOSED PAD
67% PRINTED SOLDER COVERAGE BY AREA
SCALE:10X

4214993/A 07/2013

NOTES: (continued)

5. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.

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